



ELABO GmbH, Hotline ++49 7951/307-202 www.elabo-testsysteme.com



Operating instructions **HV AC-Tester** G1-1G/T G1-1H/U

Full-electronic High Voltage-Tester



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A OPERATING ELEMENTS







| device typs | with display | no display | DC IV1 | AC | current | ¹⁾ EN50191 | |
|--|-----------------|---------------|-----------|------|---------|-----------------------|--|
| G1-1G | X | alopiay | [*] | 5000 | 100 | | |
| G1-1T | | x | | 5000 | 100 | with option E03 | |
| G1-1H | х | | | 3000 | 200/ | | |
| G1-1U | | х | | 3000 | 200 | | |
| 1) safety current limitation according EN50191 | | | | | | | |





Note HV-tester with floating output voltage:

Connect the ", -/~ " X3/X12 pole of the test voltage (hot pole) to the housing (PE) of the test object - or if grounding is necessary, to PE. This is necessary to get a high measuring accuracy.

Info about device versions and options

The device can be delivered with some optional features, this options are completes or enhances the performance range of the device. Some optional features are only as single option possible. ELABO completes the number of options constantly (as required). Optional features of the device, are described in the appendix "Options"



| No. | Equipment | Function |
|-------|---|--|
| F1 | Fuse drawer | Adapter for mains fuse |
| S1/H1 | Toggle switch/pilot lamp | Mains switch with indicator lamp |
| S2/H2 | Illuminated button Reset (red) | Switching OFF test voltage / Reset |
| S3/H3 | Illuminated button Set (green) | Ready for testing Starting test run (only at display devices) |
| H4 | TouchDisplay | Operating of the tester |
| X1 | Cold appliance mounting jack with fuse adapter 10 A | Main cable connection / mains fuse (fine wire fuse T 3.15 A - 5 x 20 mm) |
| X2 | HV-jack | Connection high voltage ~ (high potential) |
| X3 | HV-jack | Connection high voltage ~ (low potential) |
| | | |
| | | |
| X6 | Socket (Warning Lamps) | Connection warning lamps |
| X7 | Socket (D-SUB 25pole) female | DA-interface - digital Inputs/Outputs, Safety circuit |
| X8 | Socket (D-SUB 37pole) male | DA-interface - additional digital/analog inputs/out- puts (options) |
| X9 | RJ45 (DSUB, USB) - socket | Ethernet bus interface (RS232, USB - option) for automatic control of the tester (and firmware update of touch display module) |
| X9a | Socket (D-SUB 9pole) | RS-232 - Service-interface (firmware update control module) |
| X11 | HV-jack | Connection high voltage - parallel to X2 |
| X12 | HV-jack | Connection high voltage - parallel to X3 |



1 INTRODUCTION

The safety of all personnel who come into contact with the tester essentially depends on an adequate understanding of the device. For this reason:

Prior to the first putting into operation read these operating instruction!

Note on operating instructions!!

These operating instructions apply to devices with and without the touchscreen display. The menus shown can be useful for illustrating the functions on devices without a display and therefore contribute to an improved understanding of the device.

1.1 GENERAL INFORMATION

These operating instructions will make it easier to become familiar with tester and its possible uses prior to placing in operation, and to use it correctly. They contain information that will ensure functionally correct, cost-effective and safe operation and they must always be available in the place where the device is used.

The operating instructions are not only an indispensable aid for new trainee operators, they also contain useful tips, information and suggestions for the experienced operator. They are a necessary reference work for all users. By reading the operating instructions

- Hazards will be avoided
- · Operating sequences will be optimised and accelerated
- Repair costs and downtimes will be minimised
- Reliability and service life will be increased

The operating instructions should also be read carefully by the device owners and managerial staff. In particular in relation to transport and installation, as well warranty aspects.

In chapter 2 important safety instructions and information about hazards is given that will prepare you for hazardous situations that may occur. Reading up during operation is unfortunately too late. Also note the following basic principle:

Cautious and careful working is the best protection from accidents!

The quality of the tests performed using the device is crucially dependent on maintenance and care. Regular maintenance work and care are described in these operating instructions. If repairs are necessary, we will be pleased to provide you with support and supply you with the necessary original spare parts.

If you have questions after reading the operating instructions, the ELABO hotline (telephone +49 7951/307-0) is available to provide information.



SO

•1



1.2 ABBREVIATIONS AND SYMBOLS

Special option that is not included as standard

List, here the recommended sequence of actions is to be followed

List

CAUTION ELECTRIC HIGH VOLTAGE - DANGER TO LIFE!

Hazardous point, risk of serious injury to the operator and other personnel! - chapter 2.1

Risk for the device! - chapter 2.1

Information on efficient and cost-effective operation - chapter 2.1

1.3 SHORT DESCRIPTION OF THE TESTERS

The tester G1-1G/-1H are designed for operation by using the integrated touchscreen display and also via interface.

As an alternative, the device G1-1T/1U are intended to be controlled using an external PC/PLC. For this reason there is no display.

The modular design of the tester permits optimal adaptation to the individual needs of the user. Expansion modules, standard accessories and individual accessories offer the right solution for every application.

The basic devices available are automated devices (without display) for use in test systems and "stand-alone" devices (with display).

By optional features the devices can be equipped with additional functions.

The uses for the device family range from an individual manually operated test bench, through a PC-controlled test station (with control, evaluation, statistics and test plan management via PC software) to a complex fully automatic test station with conveyor belt, autom. contact, labeling etc..

ELABO offers a modern software package for controlling this device series and the management of the data via a PC.

Devices with touchscreen display

The user can be operated entirely using the touchscreen panel. This operation covers the control of the device during the test, the generation and management of test steps and test plans.

The display informs the operator at all times about the parameters and the status of the tests.

The device is used to perform an dielectric strength test on electrical devices, machinery, components and insulating materials that, in accordance with the applicable safety regulations, must be tested using a AC voltage.

The high voltage is primarily generated using an internal HV source with a high clock frequency and is regulated fully electronically. As a result the HV settles within less than 10 ms. Due to the internal source, low ripple <3% (as per VDE 0432-1) can be realised during DC tests with high currents.





The electronic voltage ramp up makes it possible to perform tests on electronic devices that can only be tested non-destructively by slowly increasing the test voltage or on test objects with high self-capacitance. Due to the fully electronically regulated test voltage, the variable transformer otherwise used is not necessary. The current and voltage measurements are made on the high voltage side. An integrated residual voltage measurement ensures safe discharge of test object capacitance.

Attention high voltage mortal danger! The resistance measurement is not current-limited, it is performed with the full HV current.

Attention discharge currents - Danger for Life !!

Particularly valid for test objects with internal capacitance (capacitors).

Particularly if HV tests with direct current (DC) are performed, test objects with internal capacitances are capable of storing high charges. After disconnection, these charges may be compensated via the body of the operator (when touching the contacts).

If the test object remains connected to the HV tester sufficiently long after switching OFF the high voltage, it will automatically be discharged via the HV-tester. Prerequisite for this: If discharging is prevented (disconnection), "extremely dangerous discharge currents" may be generated.

PC software (option)

By controlling the tester via a PC/PLC all the advantages of modern software can be exploited. Graphic, colour user prompts enable the operator to see the status of the tests at a glance. Test parameters can be saved in test plans, access control using passwords is possible. The test data can be evaluated using Accept/Fault statistics. Other advantages are the acquisition of barcodes using scanners, data integration via in-house networks, communication with conveyor belt controllers, etc..

Important note: To connect the test object to the device, a connection box or a connection panel is required. Another possibility is installation in a test system (rack) with suitable power supply and switch panel.



1.4 Standards supported

The device supports tests, e.g., in accordance with:

- EN 60335-1 Household and similar electrical appliances. Safety
- EN 60598-1 Luminaires
- EN 60950 Information technology equipment. Safety
- EN 61010-1 Safety regulations for electric measurement, control and laboratory equipment
- EN 60601 Medical electrical equipment

1.5 NAME PLATE

ELABO tester

The name plate (example) is on the rear of the device.





2 SAFETY INSTRUCTIONS

Before working with the tester the operating instructions and all enclosures must have been attentively read and understood by all persons operating the tester. The tester may be operated by trained and skilled staff only.

When the device is in operation, voltages of up to 5000 AC Volt can be produced. If the device is fitted with options, significantly higher voltages can occur. There is mortal danger when working with high voltage! ELABO has therefore equipped this device and all its components with all the necessary safety features to protect the user against hazards that may occur during correct use. Please note:

CAUTIOUS AND CAREFUL WORKING IS THE BEST PROTECTION FROM ACCIDENTS !

2.1 MARKINGS FOR SAFETY INSTRUCTIONS AND WARNINGS

Danger Zone

Electric High Voltage - danger to life !

IN DEALING WITH HIGH VOLTAGE THERE IS DANGER TO LIFE!

This marking warns of a point that is hazardous due to high electrical voltage. It is given beside all work steps during which there is **risk of serious injury** for the operator or others. It is given beside working and operating procedures that are to be followed exactly to ensure people or the tester are not endangered by high electrical voltage.

PAY ATTENTION TO THE NOTES AND ACT VERY CAREFUL IN THESE SITUATIONS. ALSO PASS ALL SAFETY REGULATIONS ON TO OTHER OPERATORS.

Caution !

This sign signifies **danger for the tester** in case of non-observance of instruction.

Note!

This sign signifies that a more effective and more economic use of the tester is possible.

2.2 WARRANTY

Claims under the warranty can only be made if the warranty conditions in the general terms and conditions are followed. The conditions in the operating instructions are also to be observed.









2.3 USE AS PER SPECIFICATIONS AND EXCLUSION OF LIABILITY

The tester is only allowed to be used for the intended tests. Any other usage is considered incorrect. ELABO is not liable for any resulting damage, the risk is borne solely by the user. Correct usage also includes compliance with the information in these operating instructions.

The tester and its components have been developed and built for usage in an industrial environment. In accordance with DIN EN 55022 ITE, this system is a class A appliance. Neither the tester as a complete unit nor its individual components are allowed to be used in a different environment. If this information is not followed, ELABO accepts no liability whatsoever for any interference produced and the resulting damage.

Prior to working with the tester, these operating instructions and all appendices must be carefully read and understood by all personnel operating the tester. The tester is only allowed to be operated by trained personnel.

The safety features and design of the tester are not allowed to be modified. Any change requires the express agreement of ELABO.

Unauthorised changes to the tester, as well as the usage of spare parts, accessories and additional equipment that has not been tested and approved by ELABO may degrade the function and properties of the tester. ELABO is not liable for resulting damage.

ELABO does not accept any liability for damage resulting from the failure to follow the operating instructions or due to failure to take due care during transport, installation, handling, operation, care and maintenance or repair of the device, even if specific mention of this duty to take care is not specifically highlighted in these operating instructions.

2.4 GENERAL RULES OF CONDUCT AND SAFETY INSTRUCTIONS

The tester is built to the state-of-the-art and recognised safety rules. Nevertheless, during operation there may be a risk of serious injury to the user or other personnel, or damage to the device or other property.



The tester is only allowed to be used in correct working order and correctly taking into account the operating instructions. Malfunctions that may degrade safety are to be rectified without delay.

Managerial staff must ensure personnel tasked with working on the tester have read and understood the operating instructions prior to starting work. The managerial staff have the obligation to only ever operate the device in correct working order and to ensure the operators use the tester correctly.





These operating instructions must always be available in the place the device is installed. Incomplete or illegible operating instructions are to be replaced without delay. In this situation we would of course be pleased to be of assistance.

In addition to the operating instructions, statutory, generally applicable and other binding regulations for the prevention of accidents and for the protection of the environment are to be followed.

Note:



DIN EN 50191 (VDE 0104) regulates the operation of test systems. Follow the stipulations in the DIN standard.

2.5 Protective facilities / Emergency Off

- All the system's safety features are to be checked for correct function prior to putting into operation each day.
- Prior to placing the system in operation, all safety features must be correctly fitted and functional.
- Safety features are only ever allowed to be removed for repair.
- Safety limit switches are not allowed to be bypassed.

2.6 Operator qualifications

- The operators must hold an appropriate qualification to operate the system. The operators must be informed and instructed about the function and especially the risks and hazards related to the system.
- Anybody who works on the system must have read the operating instructions, be familiar with the content and follow it.
- The responsible superior has the obligation to instruct the personnel based on the operating instructions.
- Temporary employees and trainees are only allowed to work on the system under the supervision of appropriately qualified personnel.
- The responsibilities of the personnel are to be clearly defined.

2.7 Working clothes (personal protection equipment) and protection at work

- Wear the necessary working clothing for your activity, e.g. ESD footwear, safety shoes, flame-retardant clothing, etc. Obtain information on this issue from your supervisor or the safety officer.
- If necessary, wear hearing protection.



2.8 Maintenance

- The stipulated maintenance and inspection work is to be performed at the intervals defined.
- Inform operators prior to starting maintenance and service work.
- During all maintenance and inspection work, electrically isolate the device / system and secure against unexpected switch on.
- The work is only allowed to be undertaken by appropriately trained personnel, all safety precautions are to be taken.
- To perform maintenance and servicing work, workshop equipment appropriate for the work to be performed is imperative!

2.9 Moisture and humidity

- The parts of the system are not allowed to be subject to moisture, humidity and/or dust.
- Particularly the electrical parts and the test mechanism and test sensors for the system must be protected against moisture, humidity and dust.

2.10 Compliance with the technical data

- The technical performance data as per the name plate must not be exceeded.
- The fuse protection for the supply cables must not be higher than the max. value defined by ELABO.

Physical/design changes to the system/device 2.11

Without the prior written approval of ELABO, it is not allowed to make changes, additions or modifications to the system. If this instruction is not followed, the device/machine/system will lose its EC conformity.

- Immediately replace parts that are not in correct working condition.
- Only use genuine spare parts. Only these comply with the technically defined requirements.

2.12 Other information

Escape routes: The escape routes are to be kept clear.



In accordance with UVV "Elektrische Anlagen und Betriebsmittel" (Electrical installation and equipment) "DGUV Vorschrift 3" section2, para. 3 - the term Elektrofachkraft (electrician) is defined as followed (translation of the original German text):

An electrician in the context of the prevention of accidents is a person who, due to his/her specialist training, knowledge and experience, as well as knowledge of the application regulations is able to assess the work allocated and recognise possible hazards.





2.13 Information on the high voltage



Attention high electrical voltage - mortal danger!

IN DEALING WITH HIGH VOLTAGE THERE IS DANGER TO LIFE!

When performing tests using the device you will be working with a high voltage up to 5000 Volt AC or 6000 Volt DC. If the device is fitted with options, significantly higher voltages can occur. There is mortal danger when working with high voltage!

Follow DIN EN 50191 (DIN VDE 0104). The EN standard regulates the operation of test systems and test benches.



Attention high voltage: The contact elements used for the HV and IS test (test probes etc.) must be designed for the maximum voltage supplied by the device.

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3 PUTTING INTO OPERATION

3.1 TRANSPORT AND INSTALLATION

The tester is supplied fully packed and is only allowed to be removed from the packaging in the immediate vicinity of the installation location.

The device can be installed in a suitable industrial rack or housing for 19" plug-ins. The device must be secured against **unintentional movement**.

The surface on which the device is installed must be appropriate for the weight of the tester (approx. 30 kg!) and always provide a secure mounting for the device.

During installation it is to be ensured the labels with information and safety labels on the device are not covered.

3.2 AMBIENT CONDITIONS

The tester is not allowed to be operated in a dusty, inflammable, aggressive or humid environment. The values permitted for temperature and atmospheric humidity are given in chapter 9 "Technical data".

3.3 INSTALLATION IN HOUSING OR RACK

Note: Slide the device carefully to the rear to the stop. Do not jam the device on insertion.

After the inserting the device in a housing, it must be secured at the front using 4 screws.

Operation with a loosely inserted tester is not allowed!

Installation without a modular system or housing is not allowed.



Fig. 3.1: Tester with out display installed in 19" / 4HU housing











3.4 Connection to the connection box / connection panel / test system



Fig. 3.2: Principle of connection via HV-test probes



Fig. 3.3: Principle of connection via Box and HV-test probe (



Fig. 3.4: Principle of connection via Box (only permissible in cooperation with a two-hand control unit - ELABO order-no. F9-1L).

Note: Principle of connection for tester with voltage feedback, see chapter 15.2 (only DC-tester).





Fig. 3.5: Principle of connection with option E09 (LEMO socket - only DC-tester).

3.4.1 Requirements for connecting lines to the test object

Under the requirements (current, voltage, mechanical stress, handling, et cetera), must be used appropriate and certificated connecting cables and contacting devices.

Use high quality cables: Insulation material with: - a low dielectric constant; -low dielectric loss factor; - a high insulation resistance. In addition, an effectual voltage strength, is necessary.

Voltage strength: The connecting lines must be certificated and tested, for the maximum voltage of the test device.

Current: The connecting lines must be certificated and tested, for the maximum current of the test device. Have attention for con ti nous test.

Mechanical stress: The connecting lines must be constructed for the mechanical stress, at the test place. If necessary, - place the cables in safety positions; - use a cable protective tube; - or use other approbate precautions.

Handling: The connecting lines must be well to handling. Use elastic, fine-wire cables, with sufficient lengths. Have attention for the weight of the cables.

Have attention for other risks on the test place eg. humidity, hotness, chemical hazard \ldots .

3.4.2 Cable length

The length of the measurement lines must be constructed, as long as necessary, however as short as possible. Long connecting lines exhibit possibly a relatively high reactive part. It has a substantial influence on the high voltage measurement, in the small measuring range (special with devices \leq 10 mA). A similar case is valid for the insulation resistance measurement, in the range >= 100 MOhm (only for DC-dervices).



3.5 Mains CONNECTION

The device is connected to the mains using a mains cable with a plug with an earth contact.

Mains connection 230 V/49 - 61 Hz, mains fuse protection 16 A (provided by the customer).

3.6 USING AND CONTROLLING

Prior to connecting the device to the mains, the following preparations must be made and the following instructions observed.

The tester can be used as a "stand-alone" device (separate housing) or in automatic test systems (rack). In the case of devices with a touchscreen display, the device can be operated manually or using external control. In the case of automated devices, control must in all cases be via an external computer.

The device is controlled remotely in conjunction with the RS232 interface X8 or Ethernet or USB interface on the rear of the housing. It is then **only possible to define the test parameters using the interface (remote mode)** (test voltage, Imax, Imin, Umin, etc.). The DA interface is to be connected as per the pin assignment given in chapter 6.2.4. The commands for the RS-232 / Ethernet interface are listed in the separate manual "Remote control via interface".

For safety reasons the device has two ,safety circuits' SK1 and SK2 , see chapter 14.8. If the safety circuit is interrupted, the high voltage is switched off immediately. It is not possible to apply the HV with a safety circuit open.

The safety circuit(s) must always be closed for test operation.

3.7 Connection to the computer

The device must always be controlled remotely via an interface:

- Ethernet- or RS232-/ USB interface (option), depending on the options fitted to the device.





3.8. Operating touchscreen display

Touchscreen displays are touch-sensitive monitors. Areas are defined on them that represent, e. g. buttons (touch buttons), fields and message windows. There is in principle no difference between the operation of "touch buttons" and pressing normal buttons. You operate touch buttons by touching them with a special "blunt" stylus or your fingertip.

Errors due to triggering actions unintentionally!

Always only ever touch one point on the screen.

Damage to the surface of the touchscreen display!

Do not use any pointed, sharp or hot objects to operate the touchscreen display

3.8.1 Entering arbitrary numerical values

- Touch the field where the entry is to be made (e.g. test time, actual value for the voltage, etc).

The system opens a numerical keypad.



Fig. 3.6: Numeric keypad

The top line indicates the value currently entered (e.g. 15).

- Change the actual value by touching the number fields.
- Accept the value entered by touching the "Enter" field. The new value is accepted as the actual value.



3.8.2 Entering arbitrary text

The screen permits the entry of passwords, test plan names, descriptions, comments, etc.

- Touch the field where the entry is to be made (e.g. details, class names, etc).

- The screen is displayed automatically if an entry (e.g. password) is ex-

back to the mask before



Text box (max 256)

Deletes the character on the left of the cursor

Accepts the entry as the actual value

Fig. 3.7: Screen keyboard for text entry

The text box indicates the text entered, in the case of passwords "######" characters are displayed.

- Enter your text by touching the alphanumeric fields.
- Accept the text entered by touching the "Enter" field. The text is applied.



3.9 Password protection

For the device with a touchscreen display, there is 3-level password protection. The passwords can be activated and deactivated independently of each other. The passwords for the individual levels can be set separately.

Passwords are defined using the "Setup" button, see chapter 10.6.

3.9.1 Password level 1

Protection against unauthorised usage of the device. It is not possible to make any changes to the test parameters or in the setup of the device. It is possible to load an existing test plan and execute the test. Changes at existing test plans are not possible.

ELABO default setting "MESS"

3.9.2 Password level 2

Protection against changes to the "test parameters". Prompt after opening "Test plans", "Manual test" or "set of parameter".

ELABO default setting "PARAM"

3.9.3 Password level 3

Protection of the "settings" and Result browser menu. Prompt after opening the menu.

ELABO default setting "SETUP"



Fig. 3.8: "Start menu" password levels

Note: On entering of the pass word, the level is unlocked permanently. The anew entering of the pass word is then on the next boot-up of the tester, necessary.

Note: If individual passwords no more known, it is possible to reset the old pass word by using a universal pass word, see also chapt. 10.6.

ELABO

3. MAKEREADY



Fig. 3.9: Password levels "e.g. High voltage test"



3.10 Switching on

Prerequisite:

- The device is installed in accordance with chapter 3.1 to 3.3.
- The device is connected in accordance with chapter 3.4 to 3.7.
- Chapters 3.8 and 3.9 are familiar.

• Switch the mains switch S1 to the "I" position.

The mains indicator H1 in the switch illuminates.

The system is booting up and the display indicates the startup screen for approx. 5 s.

Now a the display is dark for approx. 5 s.

The display reports now

Type serial no. software version



Fig. 3.10: ELABO Startup-screen



Fig. 3.11: ELABO Startup-screen

After the boot process, the device indicates the "main menu".



Fig. 3.12: Main menu

Note: As delivered all passwords are activated. If a menu command is selected, the password prompt appears, see chapter 3.9 further forward in this document.



3.11 Changing language

Language setting for the menu system*).



Fig. 3.13: Language setting

- Select the "Settings" menu command (password level 3 necessary).
- Set the required language , by touch to the language field..
- Close the setup menu.
- Accept the .changes.

The change to the language will only be permanently active after you save the changes, see also chapter 10.6. Setup.



3.12 STATE past switch ON HV/IS

The device has a mains switch. After the application of the supply voltage, the device is placed in operation by switching on the mains switch.

After the mains switch is switched on, the built-in mains indicator H1 illuminates. The green indicator on the front panel is also briefly illuminated. If the optional warning lamp set (chapter 7.2) is connected, its green indicator also illuminates.

Devices with touchscreen display: After booting the operating system the touchscreen menu appears, see chapter 3.10.

Remote control mode: A high signal is applied to pin 4 on X7. The device is controlled using the digital interface (X7) in conjunction with the RS232 /Ethernet/USB interface.

Interface only operation: A low signal is applied to pin 4 on X7. The device is controlled only via the RS232 or Ethernet interface.

Two starts mode: Two start signals are always necessary to apply the high voltage. These can be: two start commands via the interface, or in the "Remote mode" a "digital" start and a start command over the interface (pay attention to sequence for commands). In the "Local mode" (front panel) the green Set button must be pressed twice.

| Front panel only | | | DA interface and RS232/Ethernet/ USB | | | | RS232/Ethernet/USB only | | Ethernet/USB | | |
|----------------------------|-----------|---------------|---|-------------|--------|-------------|-------------------------|-------------------------|--------------|--------|-------------------------------|
| Operating mode | | | | Front panel | | Digital X7 | | RS232 X8 Ethernet X9 | | | Only RS232 X8 Ethernet X9/ |
| | SK1 | SK21) | Remote | Set button | Remote | Set HV | Set PE | | | Remote | |
| | X7-21 | X7-15 | X7-4 | | X7-4 | X7-2 | X7-5 | | | X7-4 | |
| | | | | | | | | | | | |
| | off | off | low | | low | low | low | | | low | |
| | | | | | | | | | | | |
| HV ready for test | on | on | low | 1. Start | high | high (edge) | low | | | low | set HV (1) |
| | | | | | | | | | | | |
| HV ON | on | on | low | 2. Start | | | low | set HV (2) | | low | set HV (2) |
| | | | | | | | | | | | |
| | | | | | | | | | | | |
| ¹⁾ See also Cha | pt. 6.2.3 | "Digital Inte | erface X7" | | | | | | | | |



Fig. 3.14: Signal table

Note: Define the value for the test voltage and the Imax limit, as well as start/stop voltage and ramp speeds and any other parameters as necessary via the touch-screen display or interface (remote mode).

For more detailed information see chapter 10.



3.12.1 SWITCH ON HV/IS

The diagram shows the states for the HV-test. All prerequisites must be met for the high voltage test (see also state table further forward in this document). The safety circuit(s) must be closed.



IN THE "HV ON" STATE THE HIGH VOLTAGE IS APPLIED.

THERE IS MORTAL DANGER WHEN WORKING WITH HIGH VOLT-AGE! FOR THIS REASON: WORK PARTICULARLY CAREFULLY AND CAUTIOUSLY!

Note:

If the "SET" and "RESET" signal (X7, pin 3) are present at the same time, the "RESET" command has priority: there is no start.



Fig. 3.15: 1. and 2 starts mode



The **red illuminated push-button** S2/H2 illuminates and the actual values for output current and output voltage are indicated or can be retrieved via the interface.

For information on the selection of the other settings (AC/DC switching, trigger mode, measurement type, voltage set-point definition, etc.), as well as error messages: see chapter 5 and 10.



| | Ready for switch on | HV ON | Fault |
|-------|---------------------|-------------|----------|
| S2/H2 | flashing | illuminated | flashing |
| S3/H3 | off | off | off |

3.12.2 STATES IS (only DC-Devices)

Note: Define the value for the IS test voltage as well as the start/stop voltages and ramp speeds as necessary using the touchscreen display or interface (remote mode).

Define the value for the measurement range, the Rmin/ Rmax limit, as well as any other parameters as necessary using the touchscreen display or interface (remote mode).

Attention - High Voltage - Danger For Life: the IS test is undertaken using DC high voltage.



The states are the same as for the high voltage test, see further forward in this document.





3.13 CONTACT MONITORING

On the usage of the device in automatic systems, in many cases it is necessary to check the contact to the test object. One possible method of performing this check can be to monitor the current flowing through the test object with the high voltage applied.







Fig. 3.18: Contact monitoring



3.14 SAFETY CIRCUITS SK1 and SK2

The high voltage device is equipped with two safety circuits. Operation with a second safety circuit increases the safety on test systems with guards.

ONLY AN ELECTRICIAN IS ALLOWED TO WORK ON THE SAFETY CIRCUIT, WITH THE DEVICE ELECTRICALLY ISOLATED FROM THE MAINS (UNPLUG FROM THE MAINS SOCKET).

Attention:

Faulty safety circuits are only allowed to be repaired by an electrician with appropriate skills.

Attention:

The managerial staff must ensure the safety circuit works correctly, on site, immediately after the completion of the repair.

Note: SK1 is closed by connecting to Ue SK2 is closed by connecting to GND

3.14.1 Fault in the device's safety circuit

Important: If a malfunction is found in the safety circuit incorporated in the device, testing must be interrupted immediately. No further tests are allowed. The device must be sent to ELABO for repair without delay.



4. OPERATING MODES



4 OPERATING MODES

The device permits high voltage tests without ramp and with ramp. The illustration below gives an overview of the voltages and currents.



Fig. 4.1: Voltages and currents (special devices are different)

4. OPERATING MODES







4. OPERATING MODES



4.2 Normal-Mode Test sequence




HV- / ISO- test Normal-MODE Start HV- / ISO- test Normal -MODE HV-Prüfung? yes Type of voltage Voltage range Minimum voltage Parameterisation for HV-test, test limits Parametrisation for Isulation test, test limits Type of voltage Voltage range Minimum voltage Command: \$SU1(...) Command: \$SU2(...) Command: \$SU2(...) Command: \$SI1(...) Command: \$SR1(...) Command: \$SI2(...) Command: \$SI2(...) Delay time Delay tin Primary state Command: \$SHT fault confirmation Command: SLTS get status of the test unit Status of the test unit fault confirmation depending error? no Command: \$SST or digital START signal + ext. remote (X7) set device ready 1. START Status of the test unit get status of the test unit Command: \$LTS ŧ Start info Digital start present? hood is closed, test sequence will be started Command: \$SST 1prepaire test? yes ecting test vol d safty function prepa started by digital signal? _no ↓ get status of the test unit Command: \$LTS Status of the test unit ÷ depending error? no unit ready for test sequence and the for connecting voltage us test sequence yes 4 test unit ready for onnecting test voltage 2. START for starting the test sequence Command: \$SST test voltage connected? yes test voltage is present on output (test sequence is running!) Stop a continuity test. Cancel a test sequence with Command: \$SHT or E digital STOP signal get status of the test unit Command: \$LTS Status of the test unit test unit in primary state? ne yes Error during test sequence? nein

Ende

4.2.1 HV/IS-test normal mode

Note: ISO-test only at DC-devices.









4.2.3 Normal mode output step





4.2.4 Normal mode time step









Note: ISO-test only at DC-devices.



4.3.1 Fast-Start-Mode HV-ISO-Test



Note: ISO-test only at DC-devices.

5. ERROR MESSAGES



5 ERROR MESSAGES

Depending on the priority of the error, in some circumstances the high voltage is switched off.

At the same time the text describing the error is indicated on the display and the related outputs on the interface X7 set (cf. chapter 6).

The text describing the error and the errors messages are cleared once the error has been acknowledged using the red illuminated push-button (S2/H2), on the digital interface using RESET (X7, pin 3) or using the serial command "\$SHT", and the faults have been rectified.

The table below gives an overview of the possible errors and their consequences. An error with a higher priority (further up in the list) will be superimposed over a lower priority error and suppress its message.

Abbreviations and explanations on the information in the table:

- BB State READY (chapter 3.12)
- E State ON (chapter 3.12).

Poll using "\$LTS" command Z column (see appendix for documentation on remote control).

| State | Fault | Digital outputs | | | | | RS232 | Action | Acknow- |
|-------|--|-----------------|---------------|----------------|--------------|----------|---------------|---|----------------------------|
| | | | | | | | Status | | ledgement |
| | | Ac- cept | > max | Sys-Fault | HV-ON | H2 | Error code | - | of the error necessary? |
| BB | SK - Safety circuit open | 0 | 0 | 0 | 0 | off | 9,10 | No start | no |
| E | l > Imax flash over | 0 | 1 | 0 | 0 | flashing | 5, 50;51 | High voltage switched off | yes |
| E | Over temperature | 0 | 0 | 1 | | flashing | 14 | High voltage switched off, leave to cool down | yes |
| E | SK offen (Safety circuit open) | 0 | 0 | 1 | 0 | flashing | 9,10 | High voltage switched off | yes |
| E | HV-voltage is not reached U < Umin | 0 | 0 | 1 | 0 | flashing | 2,3 | High voltage switched off | yes |
| E | Reset via S2 "User break" or via command "\$SHT" | 0 | 0 | 1 | 0 | flashing | 8 | | yes |
| E | Test time not finished | 0 | 0 | 1 | 0 | flashing | 4 | High voltage switched off | yes |
| E | Contact monitoring I < Imin | 0 | 0 | 1 | 0 | flashing | 6 | High voltage switched off | yes |
| E | Timeout: switch off residual voltage monitoring | 0 | 0 | 1 | 0 | flashing | 15 | High voltage switched off | yes |
| E | Maximum test time exceeded | 0 | 0 | 1 | 0 | flashing | 16 | High voltage switched off | yes |
| E | No error | 1 | 0 | 0 | 0 | off | 0 and 1 | High voltage switched off after test time elapsed | no |
| | Digital output "HV-ON" is only s | switchec | d on (1) if i | the high volta | ige is appli | ed. | | | |



6 CONNECTIONS / INTERFACES

6.1 Power connections

6.1.1 High Voltage

The high voltage connectors X2 and X3 on the rear and X11 and X12 at the front are used as an output for the test voltage.

- X11 (+/~) HV socket connection to object measured
- X12 (+/~) HV socket connection to object measured. Provided for earthing the HV test voltage.



X2 (+/~) HV socket - connection to object measured
X3 (+/~) HV socket - connection to object measured. Provided for earthing the HV test voltage



6.1.2 X6 Warning lamp set 94-2C or Signal column F9-1A connection

The round connector is for the connection of the Elabo warning lamp set or signal column.

- X6-1 Phase (230 V) for green lamp
- X6-2 Phase (230 V) for red lamp
- X6-3 N for both lamps
- X6-4 Spare

ΡE



6.2 INTERFACES

Note - driver software for PC. Driver-software and driver-manuals are located at the ELABO Support CD, enclosed to the device manual. The interface and the control commands are described in the separate manual "Remote control via RS232/Ethernet".

6.2.1 Ethernet-INTERFACE X9

The Ethernet-interface is installed in the device as the standard interface. The tester receives the control commands via interface X9. Additional, the firmware update of the touch display module is possible via X9 (see also chapter 13 ELABO Lite Software).

6.2.2 USB-NTERFACE X9

The USB-interface is installed in the device as optional interface (replacement for the Ethernet-interface).

6.2.3 RS232 INTERFACE X9

The USB-interface is installed in the device as optional interface (replacement for the Ethernet-interface). The 9-pin D-SUB socket X9 is provided for the connection to a control computer. The connections DTR, DSR, DCD are not essential necessary.



Fig. 6.2: Interface cable

6.2.4 Service-INTERFACE X9a (RS232)

Use the service-interface X9a exclusive for updating the firmware of the control unit of the tester, via the ELABO Light Software (Chapt. 13).

The occupation of X9a see fig. 6.2.

Note: The control of the tester via X9a is not possible, use interface X9 for this.



6.2.5 DIGITAL INTERFACE X7

For the connection of the safety circuits and for external control, the device has a 25-pin connector X7.



Fig. 6.3: View of connector X7

Note: The inputs and outputs described in the following are connected to X7 in the standard device. Additional digital outputs can be purchased as an option.

Note: To activate the digital inputs, a voltage of +5...24V DC must be applied. For this purpose you can apply the +24V (+Ue) control voltage on pin 22. Ground is pin 17 (GNDE).

Auxiliary voltage +Ue:

This floating control voltage makes it possible for the user to control the device via the digital interface without the need to connect an external power supply.

Note: The maximum load including the outputs should not exceed 300mA.

Pin 22 +Ue (24V/0.3A)

Pin 17 **GND** (reference potential)

Safety circuit "SK1":

If this pin is connected to +Ue (pin 22) or an external power supply, SK1 is closed. In the case of operation in a test system the circuit is closed by a safety switch that is actuated when the guard is closed.

Pin 21 SK1

Safety circuit SK2

Pin 15 **SK2 (default)** - If this pin is connected to GND (pin 17) SK2 is closed (negative switching).

Pin 16 **SK2** - Using internal jumpers, SK2 can be changed to +"positive switching". SK2 is then closed by making a connection between pin 16 and +24 V DC (pin 22)..

6.2.5.1 OUTPUTS

The digital outputs are designed for "positive switching", for 24V/ approx. 50mA. The reference potential in this case is also GND.



Over current trip "I > Imax":

"Positive switching" transistor output. In case of an over current trip, the output is set to "High".

Pin 8 I>Imax Load rating: 24 V/max. 50 mA

High voltage applied "HV-On":

"Positive switching" transistor output. The output is set to "High" if the high- voltage is switched ON (HV and ISO).

Pin 9 HV-On Load rating: 24 V/max. 50 mA

Test "Accept"

"Positive switching" transistor output. The output is set to "High" if the prior test has been performed without a fault. The output stays "High" until the start of the next test.

Pin 10 Accept Load rating: 24 V/max. 50 mA

"Open cover"

"Positive switching" transistor output. This output is used to operate a pneumatically operated test cabinet. After the end of the test a pulse approx. 250 ms long is generated to open the test cabinet. This function can be disabled depending on the configuration of the device.

Pin 11 **Open cover** Load rating: 24 V/max. 50 mA

"System-fault"

"Positive switching" transistor output. The output is set to "High" if a test is interrupted prematurely, the contact monitoring becomes active, the minimum test voltage is not reached, or other system errors occur.

Pin 12 System-fault Load rating: 24 V/max. 50 mA

"External discharge relay" (only active at DC tester)

Using this output a relay can be operated that discharges the test object after the high voltage is switched off (in addition to the internal discharge). It is recommended to execute the discharging, by using a suitable resistor in alliance with the normal-closed contacts of the external relay.

"Positive switching" transistor output. The output is set to "High" when the test is started (HV applied). After the high voltage is switched off, the output switches to "Low":

- immediate with residual voltage measurement switched off
- after dropping below 3000 V with residual voltage measurement switched on
 - Pin 13 **External discharge relay** Load rating: 24V/max. 50 mA



6.2.5.2 INPUTS

A "High" signal on a digital input on the digital interface can be achieved in two different ways.

- Connect the auxiliary voltage +Ue (X7, Pin22) to the related input.
- Apply an external auxiliary voltage of +24 V DC to the related input pin. However, in this case the ground for this supply voltage is to be connected to GND (X7, pin 17).

An open (digital-) input is recognized as LOW.

Note delay-time: Between the reset-operation of an input and a following set operation of an other input, a minimum delay-time of 100 ms must exist (reaction time of the electronic, relay setting, ...).

"Set HV" Start an HV test:

The connection of pin 2 to +Ue (or an external supply voltage) will apply the high voltage. The signal can be present as pulse of 100 ... 500 ms, preferably.

Note: A "set" using this interface is only accepted if the device is in the remote control mode (pin 4 connected to +Ue, see Remote control mode)

Pin 2 Set HV

"Reset HV" Interrupt or switch off a HV test:

The connection of pin 3 to +Ue (or an external supply voltage) interrupts a high voltage test started, or clears an error that has occurred previously. The signal can be present as pulse of 100 ... 500 ms, preferably.

A **reset** signal always has priority over a **set** signal.

Note: A reset using this interface is only accepted if the device is in the remote control mode (pin 4 connected to +Ue, see Remote control mode).

Pin 3 Reset HV

"Remote" control mode:

The device is placed in the remote control mode by connecting pin 4 to +Ue (or an external supply voltage). Only then is it possible to control the high voltage tester using the digital interface.

Pin 4 Remote

Pins not connected

Pin 1, pin 5; pin 6, pin 7, pin 14,



6.2.5.3 DIO - additional digital interface (option)

See also chapter 12.

Expanded digital interface option G1-1 E06

These 6 additional digital outputs DIO1 ... DIO6, can be set/reset in the test plan. For this, appropriate presettings must be performed and input / output parameter blocks have been created. See also chapter 12. A further possibility is activation / deactivation via serial remote control (see remote control commands). All outputs are positive switching transistor outputs.

The additional digital outputs DIO1 ... DIO6 are located at the 25-pole interface XS7. The load rating per output is 24V/max. 50mA.

| DIO1 | XS7 | Pin 18 |
|------|-----|--------|
| DIO2 | XS7 | Pin 19 |
| DIO3 | XS7 | Pin 20 |
| DIO4 | XS7 | Pin 23 |
| DIO5 | XS7 | Pin 24 |
| DIO6 | XS7 | Pin 25 |

6.2.6 XS8 - Expanded digital/analog interface (option)

The additional outputs/inputs can be controlled in the device menu or via serial remote control (see remote control commands). See also Chapt. 12.

Expanded digital/analog interface XS8

- 16 additional digital outputs DASDO1 ... DASDO16
- 8 additional digital inputs DASDI1 ... DASDI8
- 2 additional analog outputs DASAO1 ... DASAO2
- 3 additional analog inputs DASAI1 ... DASAI3

16 additional digital output

The 16 additional digital outputs DASDO1 ... DASDO16, can be switched on/off in the test plan. For this, appropriate presettings must be performed and input / output parameter blocks have been created. See also chapter 12. A further possibility is activation / deactivation via serial remote control (see remote control command \$DASDO).

All outputs are positive switching transistor outputs. The load rating per output is 24 V/max. 50 mA, in total max. 500 mA.

8 additional digital inputs

The 8 additional digital inputs DASDI1 ... DASDI8, can be read-out in the test plan. For this, appropriate presettings must be performed and input/ output parameter blocks have been created. See also chapter 12. A further possibility is activation / deactivation via serial remote control (see remote control command \$DASDI).

Digital Inputs 5 - 24 V DC



| XS8 Pin | Digital | Analog | |
|---------|---------|--------|----------------|
| 1 | DIO7 | | Digital output |
| 2 | DIO9 | | max. 50 mA |
| 3 | DIO11 | | |
| 4 | DIO13 | | " |
| 5 | DIO15 | | " |
| 6 | DIO17 | | " |
| 7 | DIO19 | | " |
| 8 | DIO21 | | " |
| 9 | | DII1 | Digital input |
| 10 | | DII3 | 5 - 24 V DC |
| 11 | | DII5 | " |
| 12 | | DII7 | " |
| 13 | GNDD | | Ground digital |
| 14 | 24V | | 24V voltage |
| 15 | nc | | not connected |
| 16 | | AO1 | Analog output |
| 17 | | AI1 | Analog input |
| 18 | | AI3 | 0 - 10 V DC |
| 19 | GNDA | | Ground analog |
| 20 | DIO8 | | Digital input |
| 21 | DIO10 | | " |
| 22 | DIO12 | | " |
| 23 | DIO14 | | " |
| 24 | DIO16 | | " |
| 25 | DIO18 | | " |
| 26 | DIO20 | | " |
| 27 | DIO22 | | " |
| 28 | DII2 | | Digital input |
| 29 | DII4 | | " |
| 30 | DII6 | | " |
| 31 | DII8 | | " |
| 32 | GNDD | | Ground digital |
| 33 | 24V | | 24V voltage |
| 34 | nc | | not connected |
| 35 | | AO2 | Analog output |
| 36 | | AI2 | Analog input |
| 37 | GNDA | | Ground analog |

2 additional analog outputs

The both additional analog outputs ADSAO1 and DASAO2, can be switched on/off and set the output-value in the test plan. For this, appropriate presettings must be performed and input / output parameter blocks have been created. See also chapter 12. A further possibility is activation / deactivation via serial remote control (see remote control command \$DASAO).



Analog outputs 0 ... 10 V DC, impedance 470 Ohm, resolution 16 bit

3 additional analog inputs

The three additional analog outputs ADSAI1 ... DASAI3, can be switched on/off and read-out the input-value in the test plan. For this, appropriate presettings must be performed and input / output parameter blocks have been created. See also chapter 12. A further possibility is activation / deactivation via serial remote control (see remote control command \$DASAI).

Analog inputs 0 ... 10 V DC, impedance 2,2 kOhm, resolution 16 bit.

24 V DC - auxiliary voltage - load rating max. 500 mA.

7. ACCESSORIES (Option)



7 ACCESSORIES AND ATTACHMENTS

7.1 TEST CABINET (OPTION)

The testing instrument can be operated in connection with a test cabinet. Control is then via the digital interface in the remote control mode and the PC interface.



Test cabinet connection:



The high-voltage tester has to be disconnected from the mains (pull plug) before connecting the test cabinet!

The connecting cables of the test cabinet are put into the rear HV ports of the test unit. The control cable for the cabinet is connected to the D-SUB connector X7 (DA interface).For connection with HV-Tester, are also other types of high-voltage-plug systems possible (eg. Krönes).

Principle of operation in the two start mode:

The safety circuit (SK1) is closed by closing the protective hood. Pin 22 (U_E) is connected to pin 21 (SK1). At the same time the 1st start signal for the test is given. Pin 2 (SET) is connected to pin 22 via the auxiliary contact on the test cabinet (magnetic switch).

The second start must come from the computer via the PC interface (HV is applied - see also chapter 3.12).

Suitable test cabinets from ELABO:

- 94-3A series manual protective hood
- 94-3B series automatic protective hood (pulse)
- 94-3C series double test cabinet
- **Note:** SK2 must be shorted in the DSUB-plug in this case.

7. ACCESSORIES (Option)



7.2 WARNING LIGHTS 94-2C / F9-1A

In the case of test voltages over 1000 V the HV device must be equipped with a warning lamp set (red and green lamps). See DIN VDE 0104.



Fig. 7.2: Warning lamp set 94-2C

Before connecting the warning lamps the tester has to be disconnected from the power supply (Pull out plug!) !

The warning lamps are connected to the rear of the tester via the socket (X6).

7.3 TEST PROBES 94-2A

The high voltage tester can be equipped with 2 safety test probes for manual testing.



Attention high voltage, flashover: The contact elements used for the HV test (test probes, connection boxes etc.) must be designed for the maximum voltage supplied by the HV device.

When working with the test probe extreme caution and attention must be exercised. If the test probes are used negligently or carelessly, there is MORTAL DANGER DUE TO THE HIGH VOLTAGE!



The high-voltage tester has to be disconnected from the mains (pull plug) before connecting the test probes!

Follow all safety instructions and warnings!

The test probes are connected to the sockets on the rear of the device and secured.



Attention: The connection of test probes and other contact elements are only permit at the front or rear panel (one of both). At safety reasons, simultaneous connections at front and rear panel are not allowed.

8. MAINTENANCE AND ATTENDANCE





8 MAINTENANCE AND CARE

Prior to all maintenance work and care the device must be disconnected from the mains (pull out plug!)

The device is largely maintenance-free!

8.1 FUSE REPLACEMENT

In case of fluctuations in the mains supply or if the device is overloaded a fuse will blow. After a malfunction the fuse must be replaced.

If a fuse should blow, it is only allowed to be replaced once, if the fuse blows again after its replacement, please send the device to your nearest ELABO service centre of contact the ELABO hot line (++ 49 7951/307-202).

Only use the type of fuse stated!

Work inside the device only may be executed by an electric qualified employee.

On working inside the device it is imperative the tester is disconnected from the mains (pull out plug!) !

Mains fuse.

The fuse is on the rear of the device under the mains connector in a holder (F1).

The holder is to be pulled out and the fuse replaced. In the holder there is space for a replacement fuse.

Fuse type: T 3,2 A/250 V

8.2 CARING FOR THE HOUSING

To clean the housing only use a clean, dry, fluff-free cloth.

Do not clean the unit with cleaning agent or water at any time.



8.3 CARING FOR THE TOUCHSCREEN DISPLAY

A clean, slightly moist, fluff-free cloth is the most suitable means of cleaning the touchscreen display. Do not use any cleaning agent of other chemicals for cleaning.



9. SPECIFICATION



9 TECHNICAL DATA

9.1 Device-specific TECHNICAL DATA

| Туре | G1-1G | G1-1T | G1-1H | G1-1U | |
|-----------------------------------|--|------------------------|---|-------|--|
| mode | hand/auto | auto | hand/auto | auto | |
| | | | | | |
| high voltage | ŀ | AC | AC | | |
| safety current limitation | only with | option E03 | not possible | | |
| output voltage | 0,1 2,50 kV AC | | 0,1 1,50 kV AC 0,2 3,00 kV AC | | |
| | isolated | from earth | isolated from earth | | |
| / measurement range resolution | 10 mA 100 mA | λ / 10 μΑ λ / 100μΑ | 20 mA / 20 μA 200 mA / 200μA | | |
| tripping to | complex or | real current | complex or real current | | |
| adjusting speed ramp | 0 3 | ,5 kV/s | 0 3,5 kV/s | | |
| voltage setting error | typical 10 V | | typical 10 V | | |
| voltage measurement error | 1 % o. meas. value / ± 3 Digit (display and interface) | | 1 % o. meas. value / ± 3 Digit (display and interface) | | |
| current measurement error | irement1 % o. meas. value / ± 3 Digit (display and interface) | | 1 % o. meas. value / ± 3 Digit (display and interface) | | |
| | | | | | |
| main data | | | | | |
| test time | test time 0,5 999 s | | 0,5 999 s | | |
| nominal capacity | 500 VA | | 500 VA | | |
| short-circuit current | > 20 | 00 mA | > 200 mA | | |
| weight | 21 kg 20 kg | | 21 kg | 20 kg | |

Note: The given measuring accuracy and the digit-precisions, are always obtained on the selected measurement range, restricted on maximum of two fractional digits. This is be valid in a similar manner for display and interface and is based on the fixed string-lengths at the interface response.

9. SPECIFICATION

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9.2 Common TECHNICAL DATA

Mains connection: Operating temperature: Atmospheric humidity: Dimensions: 230 V +10% -10% / 49 - 51 Hz 10°C - 50°C 25 - 75% rel. humidity 19"/4HU, depth 360 mm

9.3 Interfaces, miscellaneous

Internal program memory (touchscreen display): >150 parameter sets Safety circuit: SK 1 SK 2

Interfaces:

digital (Standard)

6 additional digital outputs DIO 1-6 (option) expanded digital/analog outputs/inputs DAS (option)

Ethernet (Standard) and RS232 (Option) or USB (Option) service-interface (RS232)

Take into account in addition Chapt. 3.4.1 "Requirements for connecting lines to the test object" und 3.4.2 "Cable length".



10 Touchscreen display menu system

The device is operated and the device parameters and text parameters are set using the touchscreen display.

10.1 General

The menu system is provided by a dedicated display module. The display module passes the commands and parameters to the controller of the device hardware. The hardware controller is carrying out the test. The actual measured values and results are returned to the display module and displayed.

Note: The usage of the touchscreen is described in chapter 3.8. Follow the operating instructions for the touchscreen to prevent damage.

The menu system is operated solely using the touchscreen.



local operation of the device or via the interface X9 (remote)

Note: After the device is switched on, the menu commands are protected by passwords. On this topic see chapter 3.10 Password protection.





10.1.1 Overview, HV test example



Fig. 10.2e: Device-Setup



10.3 Manual test

After opening the manual test, the operator must enter the password for level 1 (MESS). Note - capitalization/small initial letters.

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The status screen for the manual testing appears.

The test parameters of the last test are actual again. They are displayed in the right column of the status screen.



Fig. 10.3: Manual test - parameter menu



load

Possibilities:

Start the test with the parameters currently set , by using the green pushbutton "RUN" at the tester or closing the safety test cabinet (SK must be closed).

load - is opening the parameter-set management for selecting and loading a parameter-set with different values. Also possible is the to modify of the test parameter values.



10.3.1 Manual test with actual parameter

The test parameters are displayed in the right column of the status screen.



Fig. 10.3: Manual test - ready for test screen

Start testing: The device now waits for the manual confirmation of the start. This confirmation can be given using the green RUN button on the device or by closing the protective hood on the test cabinet.

In the case of operation via the front panel (local) the green RUN button (S3/H3) on the device must be pressed twice (2nd start), on this topic also see chapter 3.12.1.



Fig. 10.4: Manual test - test screen - HV test running



Attention - High Voltage - danger for life:

High voltage on the test object housing! Don't touch the test object or the wiring.



After the end of the test time or manual interruption (red reset S2/H2) the device indicates the result of the test.



Fig. 10.5: Manual test - test screen - acceptable test result

If the device detects faults, the test is interrupted immediately and a corresponding error message displayed in plain text. The erroneous test must be acknowledged using the red reset button S2/H2.



Fig. 10.6: Manual test - test screen - faulty test result

Note: At active Fast-Start-Mode, the "teach"-button is showing on the display. See also chapt. 14.







(PARAM)

10.3.2 Load parameter

After opening "load", the operator must enter the password for level 2 (parameters).



Fig. 10.7: Manual test - test screen - load parameter

The menu is used for editing and adding parameter sets. Parameter sets can be assembled into test plans and in this way produce a defined test sequence (see test plan management). The related test steps must be defined for the individual test types (HV, ISO; TIME).

The existing parameter sets are listed in the left field .By touching the button "load", it is possible to open and edit the parameter set.



Fig. 10.9: Load parameter set



 Load the desired parameter set by touching the button "load". (eg. HV_1500 AC).

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10. MENU SYSTEM



Fig. 10.12: Load parameter - parameter screen

The test parameters for the test types are described in chapter 11.



- **"Test"** starts the manual test with the actual parameter values see also chapter 10.3.
- "Save" saves the changes made. You can assign a new name to the modified set or use the old name (overwrite the parameters) .
- "Selection" of a special parameter set. The parameter set selection is shown.
- "Menu" closes the parameter screen and returns to the menu before





(PARAM)

10.4 PARAMETER SET MANAGEMENT

After opening "set of parameters, the operator must enter the password for level 2 (PARAM).



Fig. 10:10: Main menu - set of parameters

The menu is used to create and edit parameter sets. **Parameter sets are the prerequisite for carry out any tests.**

- **Manual test** the actual parameter set includes the base and limit values as well as the test time for the test.
- Automatic test (test plan) single parameter sets are forming a test plan. The device is executing the parameter sets in sequence.



Fig. 10:11: Parameter set-menü





- load a list of all defined parameter sets. Mark and load a parameter set of the list. See also Chapt. 10.3.2. It is possible:
 - to start an manual test with the actual parameters,
 - to edit and save one of the parameter sets.

edit - opens a list of all defined parameter sets. Mark and edit a parameter set of the list. Edit and save one of the parameter sets.

create - For this a existing parameter set can be saved with an new name. Edit the parameter values for the new requirements. The creation of an new empty parameter set is also possible.



load

load

delete - opens a list of all defined parameter sets. Mark a parameter set for delete and confirm it.

10.4.1 Load Parameter set

Opens a list of all defined parameter sets. Mark and load a parameter set of the list.



- Open the parameter set by touch to the button "load" " (eg. HV_1500 AC).

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Fig. 10.13: Parameter set - Parameter mask HV_1500 AC

- Edit the parameter values. The test parameters it self are described in chapter 11.



- **"Test"** starts the manual test with the actual parameter values see also chapter 10.3.
- **"Save"** saves the changes made. You can assign a new name to the modified set or use the old name (overwrite the parameters) .
- "Selection" of a special parameter set. The parameter set selection is shown.
- "Menu" closes the parameter screen and returns to the menu. before



edit

10.4.2 Edit Parameter set

Opens a list of all defined parameter sets. Mark and edit a parameter set of the list.



Fig . 10.14: Parameter set - edit

- Open the parameter set by touch to the button "edit" " (eg. HV_1500 AC).



Fig. 10.15: Parameter set - Parameter mask HV_1500 AC

- Change the desired parameter value in the mask The test parameters themselves are described in Chap. 11.



"Save" - saves the changes made. You can assign a new name to the modified set or use the old name (overwrite the parameters) .

edit



10.4.3 Create parameter set

For this a existing parameter set can be saved with an new name. Edit the parameter values for the new requirements. The creation of an new empty parameter set is also possible.

| Information | | | | | |
|---|--|--|--|--|--|
| the new parameters can be generated before the existing parameters. | | | | | |
| should the parameters been pasted to a certain place? | | | | | |
| no yes | | | | | |

Fig. 10.16: Parameter set - create

no

no - shows a alpha-numeric soft key board for entering the new parameter set name.

| | Parameter name |
|-------------|----------------|
| | |
| !?(| #\$"&/()=← |
| | ERTZUIOP |
| | DFGHJKL* |
| YX (| CVBNM;:_ |
| | ock |



Yes - opens a list of all defined parameter sets. Mark the position in the list for paste the new parameter set.



•

10. MENU SYSTEM



10.4.4 Delete parameter set

Opens a list of all defined parameter sets. Mark a parameter set for delete and confirm it.

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| Parameter set | |
|----------------------------------|--------|
| HV_1500AC | delete |
| HV_2000AC | delete |
| HV_3000 AC Ramp up | delete |
| HV_4000 AC Ramp u/d | delete |
| Fig. 10.18: Parameter set - dele | te |

- Mark the parameter set by touch to the button "delete" " (eg. HV_1500 AC).

delete

Confirm by touch to the button "delete" in the information mask.

| Information | | | | |
|--|--|--|--|--|
| do you really want to delete the parameters? | | | | |
| | | | | |
| delete cancel | | | | |

Fig . 10.19: Parameter set -confirm delete





10.5 Test plan Management and Automatic testing

After opening "Test plan management", the operator must enter the password for level 2 (PARAM).



Fig. 10:20: Main menu - Test plans

The menu is used for adding test plans. Test plans contain one or more test steps and so form a defined test sequence. The sequence is displayed in the form of a list; the device runs through the list from top to bottom.

Depending on the options fitted to the device, e.g. HV steps that are used to provide information to/prompt the operator, to poll buttons or to poll/set a digital input/output (option).

To be able to assemble test plans, test steps must be defined for the individual test types (HV). This action is carry out on the main menu with "set of parameters", on this topic see chapter 10.4. "set of parameters".



Fig. 10.21: Test plan management - test plan selection
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| load | load - a list of all defined test plans. Mark and load a test plan of the list. See also Chapt. 10.5.1. It is possible: |
|--------|---|
| | to create a test plan by chose one or more parameter sets, to edit and save test plans, to start an automatic test sequence by selecting and start one of the test plans. |
| edit | edit - opens a list of all defined test plans. Mark and edit a test plan of the list. Edit and save actual the test plan |
| create | create - an existing test plan can be saved with an new name. Edit the test plan for the new requirements. The creation of an new empty test plan is also possible. |
| delete | delate - opens a list of all defined test plans. Mark a test plan for delete and confirm it. |

Note: Create test plans with " meaningful" names.









Fig. 10.24: Test plan - insert parameter set



"Test" - starts the automatic test with the first parameter set in the test plan - see also chapter 10.5.2.

"Save" - saves the changes made. You can assign a new name to the modified test plan or use the old name (overwrite the test plan).

"Selection" - of a special test plan. The test plan selection is shown.

"Menu" - closes the test plan screen and returns to the menu before

test



10.5.2 Automatic test "test" - starts the automatic test with the first parameter set in the test plan The test parameters are displayed in the right column of the status screen



Fig. 10.25: Test plan - start automatic test

The device is loading the first parameter set of the test plan (eg. HV_1500 AC).



Fig. 10.26: Test plan - first parameter set

Start testing: The device now waits for the manual confirmation of the start. This confirmation can be given using the green RUN button on the device or by closing the protective hood on the test cabinet.

In the case of operation via the front panel (local) the green RUN button (S3/H3) on the device must be pressed twice (2nd start), on this topic also see chapter 3.12.1. The 2nd-start must be carry out within 30 s. After that the device interrupts the test with error (confirmation required).





Attention - High Voltage - danger for life:

High voltage on the test object housing! Don't touch the test object or the wiring.

| 2HV AC | mode: HV (AC) |
|--|-------------------------------|
| 1.51 [kV] | U : 1.50 kV ↓ : 0.10 kV/s |
| 02.21 [mA] | |
| | t :6.0 s delay:off |
| 002.4 [5] | lmax:10.0 mA lmin :2.00 mA |
| Status: HV-test ! Attention! High Voltage | ,1/2 |
| 0.07. Automotic toot, toot correct | |



Fig. 10.27: Automatic test- test screen

The device is executing the first test. The actual test step and the number of test steps in the test plan are shown on the right below.

If the test step is finish (test time) the device is loading the next parameter set and is waiting for the manual confirmation of the start.

In the case of operation via the front panel (local) the green RUN button (S3/H3) on the device must be pressed twice (2nd start), on this topic also see chapter 3.12.1.



Fig. 10.28: Automatic test - test screen step 2 of 2



After the end of the test plan the device indicates the result of the test.



Fig. 10.29: Automatic test- test screen - result ACCEPT



10.5.3 Fault handling Auto Test

If the device detects faults or at manual interruption (red reset S2/H2), the test is interrupted immediately and a corresponding error message displayed in plain text.







Fig. 10.30: Automatic test - test screen - result fault

The faulty test must be acknowledged using the red reset button S2/H2.





10.5.4 Edit test plan

change Op

Opens a list of all defined test plans. Mark a test plan of the list to "edit" it .



Fig. 10.31: Test plan - edit



- Opens the test plan by touching the button "edit" (eg. 2HV AC).



Fig. 10.32: Test plan 2HV AC - parameter sets

- Delete or insert a parameter set in the test plan. Parameter sets are described in Chapt. 10.4.



Save" - saves the changes made. You can assign a new name to the modified test plan or use the old name (over-write the test plan).



10.5.5 Create test plan

For this, an existing test plan can be saved with an new name. Edit the test plan for the new requirements. The creation of an new empty test plan is also possible.

| Information | | |
|--|--|--|
| the new test plan can be generated before the existing test plan ! | | |
| should the test plan been pasted to a certain place? | | |
| no yes | | |

Fig. 10.16: Parameter set - create



no - shows a alpha-numeric soft key-boad for entering the new test plan name.



Fig. 10.17: Parameter set - enter the new name

yes - opens a list of all defined test plans. Mark the position in the list for paste the new test plan









10.5.6 Delete test plan

Opens a list of all defined test plans. Mark a test plan for deleting and confirm it.



Fig. 10.35: Test plan - delete



Mark the test plan by touch to the button "delete" " (eg. 2HV AC).Confirm by touch to the button "delete" in the information mask.

| Information | | |
|---|--|--|
| do you really want to delete the test plan? | | |
| delete cancel | | |

Fig. 10.36: Test plan -delete



(SETUP)

10.6 Setup (Device parameter)

After opening "Settings", the operator must enter the password for level 3 (SETUP).



Fig. 10.37: Main menu

The menu is used to setup the device parameters and operating parameters. The parameters are displayed in screen masks. The masks can be changed by touching the upper or lower arrow.

| Setup | |
|-----------|---------|
| language | english |
| time/date | change |
| lighting | change |
| display | ongoing |
| | Ļ |

Fig. 10.38: Setup part1

next mask

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Select **Language** - language setting for the menu system. The change to the language will become permanently active after the changes are saved.

Deutsch - activates the english menu.

English - activates the german menu.



Time and Date

Setting time - set the current time (time format hh:mm) e.g. 12:21).
Set time mode - for US-time (12 h) mode or european time (24 h). am - 0:00 ... 12:00 - pm - 13:00 24:00.
Set date - set the current date dependent (format DD.MM.JJJJ e.g. .13.03.2010).
Set date mode - format DD.MM.JJJJ, MM.DD.JJJJ, JJJJ.MM.DD

Set the day of the weck

Lighting - adjust the brightness of the display in percent.

display - settings for display values, test parameter and start screen.

voltage value (after testing)

actual - result, test current and test time for the last test performed are displayed, until a new test is started.
last- result, test voltage, test current and test time for the last test performed are displayed, until a new test is started.

| display | Î |
|-----------------|------|
| Voltage value | last |
| Test parameters | on |
| Start screen | main |
| | |
| | |

Fig. 10.38a: Setup display

test parameter (on the right in the test screen)

off - the right column of the test screen is clear. The datarefresh-speed at the screen is fast (relative). on - the right column of the test screen indicates the parameters for the testing. The data-refresh-speed at the screen is slower then "off".

Start screen (after boot-up)



- main after boot-up, the main screen is shown, see fig.
- 10.1.
- **test** after boot-up, the test screen is shown, see fig. 10.3. **Buzzer active** Buzzer On/Off.
 - Off the buzzer is switched off.
 - On the buzzer is active
 - Passed the buzzer sounds permanent
 - Fault interval sound for appr. 5 s
 - Short intervals manual interruption
 - Medium intervals -fault during high voltage test (limit value was exceeded)
 - Long intervals interruption at time out (residual voltage measurement, test voltage not reached, etc.)
 - measurement, test voltage not reached, etc.)
 - fault at: bonding, manual time out, mains inverse polarity, mains supply not within tolerance.

Buzzer volume - Loudness of the buzzer in percent.

| Setup | Î |
|--------------------|----------|
| buzzer active | level2 |
| pass words | change |
| device information | indicate |
| hood pulse | off |
| | |

Fig. 10.39: Setup part 2

10.6.1 P/ ass word definition

Passwords - Activate and change Passwords for the levels 1, 2, 3 (assignments of the password steps and predefined passwords - see Chapt. 3.9). The passwords for the layers are individually set able.

Note: For activating the menu "Settings - Password" the level-3 password for "Settings" is necessary.

Test- level-1

- Enter the new password for Test (see chapt. 3.9).
- Accept the new password by using the "save"- button.

The new password is now active.

Parameter - level-2 / Setup - level-3

Enter the passwords for "Parameter" and Setup" in the same way then "Measure".



| | Pass words active |
|------------------|---|
| | inactive - no password is active. |
| | active - passwords active. For starting a new function, it is neces- sary to enter the password. |
| Master pass word | Note - Password lost: By using of "PWRESET" (for old password) it is possible to define new passwords. |
| | |
| | Device information - Shows the device number, the software version and the integrated hardware of the device. |
| | Hood impulse |
| | Off - operation without test cabinet and with all other ELABO test cabinets. |
| | On - for ELABO 93-4B series test cabinet. The device device sends a pulse to the test cabinet and as a result opens the lock. The pulse is generated at the end of the test time or after a "reset". This is necessary if the device is used in conjunc- tion with an ELABO 93-4B series test cabinet. The test time is |

increased by approx. 250 ms as a result.



| Setup | Î |
|-----------------|--------|
| fast-start mode | on |
| control ranges | change |
| result storage | off |
| test plan mode | step |
| | Ļ |

Fig. 10.40:Setup part 3

Fast-start-mode -Fast mode awaits the "Teaching" of a test item. The regulation of the device is then optimized on the learned values of the test item. On similar test items can then be achieved a much faster test cycle, since the operating point is already known. See chapter 14 for details.

- Off In "Normal operation", the regulation is performed for HV / ISO to + / 10 V (Vset).
- **On-** In fast mode, the parameters of "Control ranges" are active. See also chapter 14.



Fig. 10.40a:Control ranges

Control range (only visible if fast mode is "On") – Control accuracy for HV / ISO. Minimum / maximum value to the desired value (Regulation window). Input of numeric values, see Chapter 3.8.1 "Enter free numeric values".



Results - internal memory area for test parameter with results and measurement values. By using the ELABO "Light-Software" for the G-device series, it is possible to read out this memory area. Connect the device via X9a (service interface) to your PC. See Chapt. 13 ELABO Light Software.

- Off no intermediate storage active,
- On the device saves up to 500 results.

Serial Interface - for remote control via PC.

Baud rate (for COM-Port)

Baud rate of the serial interface. The baud rate of the opposite terminal must be set to the same value. Possible values: 4800, 9600, 19200, 38400, 57600, 11520.

Standard setting COM port: Baud: 115200, Data bits: 8, Stop pulse: 1, Parity: none, Check sum on remote control: off.

Checksum

Checksum on/ off-

Test plan mode - definite the processing of the test plan

- **Auto** after manual start, the test plan will processing with out any keystroke (see also chapter 12.2).
- **Step** every test step, must be start up by pressing the start button (see also chapter 12.3).

| Setup | Î |
|-----------------|--------|
| serial port | change |
| digital outputs | change |
| digital inputs | change |
| analog outputs | change |
| | Ļ |

Fig. 10.41: Setup part 4 (DAS- interface - option E07 only)

Digital outputs / Digital Inputs / Analog outputs / Analog inputs - (only for tester with integrated DAS- interface - option E07).

change - is showing a listing with the outputs or inputs. It is possible to set individual names for the Out-/input



Fig. 10.42: Setup part 5

Device-Setup - for internal parameter. This parameter are set and edit by the ELABO-service, only. Of this reason the sub menu is password protected.



11 Test parameters

11.1 Parameters for high voltage test

On this menu the settings for the HV tests are made. Depending on which device variant you have, some of the parameters given in the following may not be available or it may not be possible to edit some parameters. The values entered are changed in the parameter set currently open. The parameters in the following relate to the standard device with 2500 V/5000 V/ 100 mA.

In case of devices with options fitted, the parameters may vary. On this topic see chapter "Options".



Fig. 11.1a: HV test parameters 1

Test mode "HV / Time / Burn"

 $\rm HV\,$ - HV-test with AC voltage 5000 V /max. 100 mA (dependent on the device type).

 $\ensuremath{\text{Time}}$ - Waiting time step, eg. time to discharging the test object past a HV-test.

Burn (option) - HV-test with AC voltage 5000 V with the maximum of test current. The over current tripping is not active.

Voltage range "low / high"

low - test voltage 100 2500 V AC

high - test voltage 200 5000 V AC

Test voltage "0.01 ... 5.0 kV AC" - set the test voltage for the HV-test .

Run up (on/off) - activates the ramp-up function of the test voltage.

off- no ramp-up function, the full test voltage is applied.

on - ramp-up function active. The test voltage is increased linearly from the start voltage up to the test voltage.



Ramp up voltage (0.00 ... 3.50 kV/s)["] - defines the amount by which the test voltage is increased linearly in a time unit. The start voltage is used as the start value, the end value is the test voltage set. After the test voltage is reached, the test time set is started.



Run back (on/off) - activates the ramp-down function of the test voltage.

- **Off** no voltage ramp down. The full test voltage is switched off abruptly. In case of test objects with integrated inductance, this action can result in switching off voltage spikes.
- **On** voltage ramp down active. The test voltage is reduced linearly from the test voltage to the start voltage as per the ramp down speed and then switched off.
- Ramp down speed (0,00 ... 3.50 kV/s) the test voltage is reduced linearly by the value given per time unit.



Fig. 11.1c: Test parameter 2- HV

Test time (Continuous / 0.5 ... 999.9 s) - the test time can be set from 0.5 to 999.9s. The test time is irrelevant in the case of "Continuous test on".

Continuous test -active. The test voltage is applied continuously. The test must be interrupted manually using the red "Reset"



button S2/H2 if a fault occurs (eg. I > Imax). The continuous test can last max. 999.9 seconds.

- **Test time 0.5 ... 999.9 s** test time active. The test voltage is applied for the duration of the test time.
- Start up voltage (on/off) defines the voltage value from which the high voltage ramp starts.
 - on (0.02 kV/s up to (test voltage 0.01 kV/s))
 - off start voltage No ramp function, the full test voltage is switched on.
- **Current measurement** enter the part of the current that is to be used for tripping.
 - real evaluation of the real part of the test current (effective).

complex- evaluation of the complex current (test current with real and reactive part).

| HV 1500 AC | Î |
|-----------------------|---------------|
| current range | 100 mA |
| tripping current (mA) | 12 |
| minmum current (mA) | 2.0 |
| | |
| | |

Fig. 11.1d: HV test parameter 3

Range (mA) - enter the measurement range in which the test current is to be evaluated. This parameter may be dependent on the voltage device type.

10 mA measurement range **100 mA** measurement range

- Tripping current (0.01 ... 10 / 100 mA): the current entered is the maximum current that is allowed to flow during the HV testing. If this value is exceeded, an HV fault (I>Imax) is indicated (test object fault HV flashover). The tripping current (Imax) is dependent on the measurement range.
- **Minimum current (0.00 ... dynamic)**: the current entered must flow during the HV testing as a minimum. If the current is less than this value, a contact fault (I<Imin) is indicated.



- off no minimum voltage monitoring.
- on (0.00 up to tripping current) minimum current monitoring active. The current range is all times 0.1 / 0.01 lower then the tripping current.



11.2 Setting parameters Burn (Option)

BURN with AC voltage, for the localisation of low insulation points inside the test object. By the over-flash of the voltage, it is possible, to welding out the insulation fault. The maximum short-circuit current at BURN is: appr. 250 mA in 2,5 kV range and appr. 150 mA in 5 kV range.

The BURN mode, don't ensures a non destructive testing, since the tripping current release is blocked. Use the BURN function only for the localisation an welding out of low insulation points.



Fig. 11.2a: HV- burn test parameters 1

Test mode "HV / Time / Burn"

 $\rm HV$ - HV-test with AC voltage 5000 V /max. 100 mA (dependent on the device type).

 $\ensuremath{\text{Time}}$ - Waiting time step, eg. time to discharging the test object past a HV-test.

Burn (option) - HV-test with AC voltage 5000 V with the maximum of test current. The over current tripping is not active.

Voltage range "low / high"

low - test voltage 100 2500 V AC

high - test voltage 200 5000 V AC

Test voltage "0.01 ... 5.0 kV AC" - set the test voltage for the HV-test .

Run up (on/off) - activates the ramp-up function of the test voltage.

off- no ramp-up function, the full test voltage is applied.

on - ramp-up function active. The test voltage is increased linearly from the start voltage up to the test voltage.



Ramp up voltage (0.00 ... 3.50 kV/s)["] - defines the amount by which the test voltage is increased linearly in a time unit. The start voltage is used as the start value, the end value is the test voltage set. After the test voltage is reached, the test time set is started.



Run back (on/off) - activates the ramp-down function of the test voltage.

- **Off** no voltage ramp down. The full test voltage is switched off abruptly. In case of test objects with integrated inductance, this action can result in switching off voltage spikes.
- **On** voltage ramp down active. The test voltage is reduced linearly from the test voltage to the start voltage as per the ramp down speed and then switched off.
- Ramp down speed (0,00 ... 3.50 kV/s) the test voltage is reduced linearly by the value given per time unit.



Fig. 11.2c: HV- burn test parameters 2

Test time (Continuous / 0.5 ... 999.9 s) - the test time can be set from 0.5 to 999.9s. The test time is irrelevant in the case of "Continuous test on".

Continuous test -active. The test voltage is applied continuously. The test must be interrupted manually using the red "Reset"



button S2/H2 if a fault occurs (eg. I > Imax). The continuous test can last max. 999.9 seconds.

- **Test time 0.5 ... 999.9 s** test time active. The test voltage is applied for the duration of the test time.
- **Start up voltage (on/off)** defines the voltage value from which the high voltage ramp starts.
 - on (0.02 kV/s up to (test voltage 0.01 kV/s))
 - off start voltage No ramp function, the full test voltage is switched on.

free page





11.3 Time-Step

The time step can be inserted in any place in the test plan. Time steps serves for interrupting the test sequence for a specified time. This is necessary perhaps before starting a function test, for switching ON and for the booting up of the test object.

The rest time is showing in test screen. Every time a interrupting of the delay is possible.

| | Time_1.5 | |
|------------|----------|------|
| test mode | | Time |
| delay time | (s) | 1.50 |
| | | |
| | | |
| | | |

Fig. 11.3: Test parameter Time

Test mode "HV / Time / Burn"

 $\rm HV\,$ - HV-test with AC voltage 5000 V /max. 100 mA (dependent on the device type).

Time - Waiting time step, eg. time to discharging the test object past a HV-test.

Burn (option) - HV-test with AC voltage 5000 V with the maximum of test current. The over current tripping is not active.

Delay time (0.5 ... 999.9 s) - for this time the test run is stopped and the device is stand by.

off - no delay . delay time 0.5 ... 999.9 s - delay active.



11.4 CALCULATION OF THE IDLE TIME (HV / ISO)

Idle time (0.1 \dots 80.0 s) means " no evaluation of the test current / insulation resistance.



Calculation of the maximum idle time, with active "ramp-up".

tidle Max = $\frac{U_{\text{test (V)}} - U_{\text{start (V)}}}{\text{ramp-up rate (V/s)}} + \text{test time (s)} - \text{Diff (min. 0.2s)}$

1 CALCULATION OF THE MAXIMUM IDLE TIME, WITH OUT "RAMP-UP".

tidle Max = test time (s) - Diff (min 0.2s)

Note: For a correct evaluation of the test current / ISO-resistance, a minimum test time off 0.2 s (Diff) is necessary, in all cases.



12 OPTIONAL OUTPUTS / INPUTS

For the device can be ordered as an option, two additional interface cards with only outputs or outputs and inputs. The installation of the optional cards must be carried out by the manufacturer, because interventions must be made in the hardware of the device. For update of a the tester with this options, sent the device to ELABO.

The device can be equipped with both interface cards simultaneously. The presence of the card must be defined in the menu Setup - device setup (pass word protected).

12.1 Base settings Outputs/Inputs

The base settings includes for:

Digital In-/Outputs the definition of a self-explanatory name.

Analog In-/Outputs the definition of a self-explanatory name, the unit (SI) and the final values (scale).

The base settings are made in the menu "Setup".



Fig. 12.1: Settings In-/Outputs





| | N e w name | Si - unit | final value |
|-------------|---------------|--------------|----------------|
| Digital OUT | Х | | |
| Analog OUT | х | х | Х |
| Digital IN | х | | |
| Analog IN | х | Х | Х |

| | Test time | Dead time | Off/ On | Min. value | Max. value | nominal value |
|-------------|--------------|--------------|------------|---------------|---------------|------------------|
| Digital OUT | Х | Х | Х | | | |
| Analog OUT | х | х | x | | | x |
| Digital IN | х | х | x | | | |
| Analog IN | X | X | X | х | Х | |

| Test plan sequence | |
|--------------------|--|
| Read Digital IN | |
| Set Analog OUT | |
| ISO-500 V | |
| HV-1000 V | |
| Set Digital OUT | |
| Read Analog IN | |
| | |

| Test plan list | |
|----------------|--|
| testplan 1 | |
| testplan 2 | |

| Read_ | Read_DIG_IN_1 | | | |
|---|---------------|----------------------------------|--------------------------|--|
| Digital inputs 0100 0000 | | | | |
| Analog inputs Analog IN_1 Analog IN_2 Analog IN_3 | :: | 000.0 5.000 0.000 0.000 | [s] [V] [V] [V] | |
| Error: digital inputs! Press <run> to read inputs! 1/4</run> | | | | |



12.1.1 Digital Output/Input Setup

For additional digital in-/outputs, the definition of self-explanatory names is possible. In the menu parameter-block definition, the tester is showing this self-explanatory name for the out-/input.

| Digital outputs | |
|-----------------|--------|
| Dig. OUT_1[1] | change |
| Dig. OUT_2[2] | change |
| Dig. OUT_3[3] | change |
| Dig. OUT_4[4] | change |
| | Ļ |

Fig. 12.3: Settings digital In-/Outputs



Fig. 12.4: Definition of self-explanatory names for I/O



12.1.2 Analog Outputs/Inputs

The expanded digital/analog interface Option G1-1 E07 (chapter 12.3) provides 16 digital / 2 analog outputs and 8 digital / 3 analog inputs.

The analog outputs/inputs are working with DC-voltage of $0.0 \dots 10.00 V$. Example: The analog output is used for generating of the nominal value of an AC supply of 0 - 230 V. In this case, the si-unit (V) and the final value of the AC-voltage (230) must be predefined for the analog output.

Chose Analog OUT.. "change" (see Fig. 12.1).

| analog outputs | |
|------------------|--------|
| analog output[1] | change |
| analog output[2] | change |
| | |
| | |

Fig. 12.5: Settings analog outputs

The display will show all analog outputs.

Chose the analog output for definition "change".

| analog outputs | |
|------------------|----------|
| Analog. OUT_1[1] | change |
| Unit | v |
| Final value | 230.000 |
| | |
| | |

Abb. 12.6: Einstellungen Analog Ausgang 1

For analog in-/outputs, the definition of self-explanatory names is possible. In the menu parameter-block definition, the tester is showing this selfexplanatory name for the out-/input. See also chapter 12.1.1.



Enter the si-unit e.g. V (Volt) if the output-voltage is used for the nominal value of a voltage.



Enter the final value e.g. 230, (10 V DC analog output voltage = 230 V result voltage on the supply).



Confirm the inputs.



12.2 Additional digital interface Option G1-1 E06

6 additional digital outputs DIO1 ... DIO6. See also chapter 6.2.5.3 "DIO additional digital interface".

For this digital outputs the numbers 1 to 6 are fix reserved.

For the additional digital outputs, the definition of self-explanatory names is possible. See chapter 12.1.

The activation (set) of outputs is only possible in test plans. See chapter 12.6.

| change |
|--------|
| change |
| change |
| change |
| |

Fig. 12.7: Settings 6 additional digital outputs E06



12.3 Expanded digital/analog interface Option G1-1 E07

The expanded digital/analog interface includes for:

- 16 additional digital outputs DASDO1 ... DASDO16. For this digital outputs the numbers 7 to 22 are fix reserved.
- 8 additional digital inputs DASDI1 ... DASDI8
- 2 additional analog outputs DASAO1 ... DASAO2
- 3 additional analog inputs DASAI1 ... DASAI3

```
See also chapter 6.2.6, "X8 - expanded digital/analog interface".
```

For analog in-/outputs, the definition of self-explanatory names is possible. See chapter 12.1.

| Digital outputs | |
|-----------------|-----|
| Dig. OUT_7[7] | on |
| Dig. OUT_8[8] | off |
| Dig. OUT_9[9] | off |
| Dig. OUT_10[10] | off |
| | ļ |

Fig. 12.8: Settings expanded digital/analog interface E07

The activation (set) of outputs is only possible in test plans. See chapter 12.6.



12.4 Create parameter blocks

Read and Set of inputs/outputs are only possible in test plan sequences on automatic test runs. For this, input / output parameter blocks must be created, before. This parameter blocks are. These parameter blocks are available now, for including in the test plans. See also chapter 12.5 "Test plans".

| Parameter set | |
|---------------|--------|
| parameter set | load |
| parameter set | edit |
| parameter set | create |
| parameter set | delete |
| | |

Fig. 12.9: Read/Set of In-/Outputs

Enter a self-explanatory name for the parameter block (see example above).

Set the required "test mode" to "Input or Output" (in this case to "Output")

Set the parameter to the required values.



12.4.1 Digital Outputs

Digital outputs can be set to 1 (on) or 0 (off) state. They can be used for the control of relay / digital inputs (have note to the output current - see chapter 6.2.6).

Chose "digital output - change".

| Test mode | OUTPUT |
|-----------------|--------|
| Digital outputs | change |
| Analog outputs | change |
| | |
| | |

Fig. 12.10: Chose digital outputs

The display will show all digital outputs.

Activate one or more digital outputs by touch to the button. The actual state will shown on the button (on/off).

| Digital outputs | |
|-----------------|-----|
| Dig. OUT_7[7] | on |
| Dig. OUT_8[8] | off |
| Dig. OUT_9[9] | off |
| Dig. OUT_10[10] | off |
| | ļ |

Note:

Fig. 12.11: Chose the digital output for setup

Additional digital interface option G1-1 E06 (chapter 12.3) provides 6 digital outputs. If option E06 is integrated, the device is showing "Dig. OUT_1 to Dig. OUT_6.

The expanded digital/analog interface Option G1-1 E07 (chapter 12.3) provides 16 digital / 2 analog outputs and 8 digital / 3 analog inputs. If option E07 is integrated, the device is showing "Dig. OUT_7 to Dig. OUT_22.


12.4.2 Analog Output

The expanded digital/analog interface Option G1-1 E07 (chapter 12.3) provides 2 analog outputs.

Analog outputs are working with DC-voltage of 0.0 ... 10.00 V.

Example: The analog output is used for generating of the nominal value of an AC supply of 0 - 230 V. In this case, the si-unit (V) and the final value of the AC-voltage (230) must be predefined for the analog output.

Choose "Analog Outputs - Change".

| SETZE_ANA_OUT_1 | |
|-----------------|--------|
| Test mode | OUTPUT |
| Digital outputs | change |
| Analog outputs | change |
| | |
| | |

Fig. 12.12: Chose analog outputs

The display will show all analog outputs.

| change |
|--------|
| change |
| |
| |
| |

Fig. 12.13: Chose analog output 1 or 2 Choose the analog output for "change".



Activate the analog outputs by touch to the button. The actual state will shown on the button (on/off).



Fig. 12.14: Setup of analog output 11

Choose "analog value". The display is show the input screen.



Fig. 12.15: Enter analog value

The info area is showing the input range (see also chapter 12.1.2).

Enter the desired output value. The device converts the input value to a corresponding target value of 0 - 10 V DC.

Save the value by using the "Save" Button.



12.4.3 Digital Inputs (Input)

The state of digital inputs can be 1 (on) or 0 (off). Digital inputs can be used for monitoring of switches / digital outputs, etc. (note to the input voltage - see chapter 6.2.6). Corresponds the state of the input not the expectation on the definitions, the unit displays "Error" and waits for user input.

Choose "digital inputs - Change"

| Read input | |
|---------------|--------|
| Test mode | |
| Digital input | change |
| Analog input | change |
| Test time[s] | 2.0 |
| | Ļ |

Fig. 12.16: Chose digital inputs

The display will show all digital inputs.

Activate one or more digital inputs by touch to the button. The query of the digital input is made to "on" or "off". The expected state indicates the button.



Fig. 12.17: Chose digital input for definition

Save the input value by using the "Save Button".





12.4.4 Analog Inputs

The expanded digital/analog interface Option G1-1 E07 (chapter 12.3) provides 3 analog inputs.

Analog inputs are working with DC-voltage of 0.0 ... 10.00 V. At definition of mi.- / max limit values, it is possible to carry-out at validation of the input voltage. Corresponds the value of the input, not the expectations on the definition, the unit displays "Error" and waits for user input.

The DC-voltage can serve for monitoring an actual value, e.g. a voltage of $0 \dots 1000$ V via transducer. In this case, the si-unit (V) and the final value of the voltage (1000) must be predefined for the analog input.

Choose "Analog input - Change".

| Read input | |
|---------------|--------|
| Test mode | |
| Digital input | change |
| Analog input | change |
| Test time[s] | 2.0 |
| | Ĵ |

Fig. 12.18: Chose analog Inputs

The display will show all analog inputs.

| Analog inputs | |
|-----------------|--------|
| Analog input[1] | change |
| Analog Input[2] | change |
| Analog input[3] | change |
| | |
| | |

Fig. 12.19: Chose the anlog input for definition

Choose the analog input for - "change".



Activate the analog input by touch to the button. The actual state will shown on the button (on/off)

| Analog input 1 | |
|----------------|---------|
| Analog IN_1[1] | off |
| Min. value | 100.000 |
| Max. value | 950.000 |
| | |
| | |

Fig. 12.20: Setup of analog input 1

Enter min.- and max. limit for the input value. The display is show the input screen.



Fig. 12.21: Enter anlog value

The info area is showing the input range (see also chapter 12.1.2).

Enter the desired min./ max. limit values. The device converts the input values to the corresponding target values of 0 - 10 V DC.



Save the value by using the "Save" Button.



12.5 Create Test plans (Input/Output)

Read and Set of inputs/outputs are only possible in test plan sequences on automatic test runs. For this, input / output parameter blocks must be created, before. See also chapter 12.4 "Parameter blocks".

Choose "test plan" in the main menu.

Create new test plans or edit existing test plans by insert "Input/Output" parameter blocks. See also chapter 10.5.

The device is providing the definite "Input/Output" parameter blocks in addition to the HV/IS -parameter block to insert in the test plan.

| Test plan_1 | |
|---------------|---------|
| Read_Dig_IN_1 | ins/del |
| Read_Ana_IN_1 | ins/del |
| Set_Dig_OUT_1 | ins/del |
| Set_Ana_OUT_1 | ins/del |
| | |

Fig. 12.22: Insert Parameter set

Insert "Input/Output" blocks in the test plan-sequence, on the desired position.



Save the value by using the "Save" Button.



12.6 Load and execute test plans (Input/Output)

Prerequisite: See chapter 12.5.



Note: The execution of test plans is possible in manual mode or in automatic mode. The setting is made in the menu "Setup - Test plan mode". See also chapter 10.4 - illustr. 10.41.

Test plan mode - step: The start of test-steps must be done by user-input (eg, push button).

Test plan mode - auto: Test-steps are running as sequence automatically.. Only if "error" an operator intervention is required.

Choose "test plan" in the main menu.

Choose "Load test plan" in the main "test plan".

Choose the desired test plan at the list. See also chapter 10.5.

| Test plan_1 | |
|---------------|---------|
| Read_Dig_IN_1 | ins/del |
| Read_Ana_IN_1 | ins/del |
| Set_Dig_OUT_1 | ins/del |
| Set_Ana_OUT_1 | ins/del |
| test 📳 🗁 | |

Fig. 12.23: Execute test plan

It is possible to edit the loaded test plan on this place (insert or delete parameter blocks).

12.6.1 Start /execute test plan (auto- mode)

Note: Test-steps are running as sequence automatically.





12.6.1.1 Read digital input

The tester is reading the digital inputs. If the reading pattern is correct (according to the settings in the parameter block), the next step is executed. If the device will find difference, error is reported. See also chapter 10.5.3 Error handling.



Fig. 12.23: Read digital input

12.6.1.2 Read analog input

The tester is reading the analog inputs. If the values are within the limits, the next step is executed. If a value is under- or overrun the limits, error is reported. See also chapter 10.5.3 Error handling.





12.6.1.3 Set digital output

Whether a digital output is set or not, is defined in the parameter set.



Fig. 12.25: Set digital output

Note: In the example illustration the **expanded digital/analog interface** Option G1-1 E07 (chapter 12.3) is integrated in the tester. The additional digital **interface** Option G1-1 E06 is not integrated. Therefore, the state of the inputs 1 - 6 is "x"

See also chapter 10.5.2 "auto testing".

12.6.1.4 Set analog output

Whether analog output is set or not and the value of the voltage, is defined in the parameter set.





See also chapter 10.5.2 "auto testing".



test

12.6.2 Start /execute test plan (step mode)

Note: Test steps are running in "step" mode. All steps must be started by the operator.

12.6.2.1 Read digital input

Press the green "Run" - button, for start the read action.



Fig. 12.27: Read digital input

In this case, the tester reports "Error: digital inputs" - forecasting: 1 signal at input 1, specified "0" in the parameter block..

See also chapter 10.5.3 Error handling:

The tester is waiting for user input.

12.6.2.2 Read Analog Input

Press the green "Run" - button, for start the read action.



The tester is waiting for user input.



12.6.2.3Set Digital Output

Press the green "Run" - button, for start the set action.

Whether a digital output is set or not, is defined in the parameter set.



Fig. 12.29: Set digital output

Note: In the example illustration the **expanded digital/analog interface** Option G1-1 E07 (chapter 12.3) is integrated in the tester. The additional digital **interface** Option G1-1 E06 is not integrated. Therefore, the state of the inputs 1 - 6 is "x".

In this case, the tester reports "Error: digital inputs" - forecasting: 1 signal at input 1, specified "0" in the parameter block.

The tester is waiting for user input.

12.6.2.4 Set Analog Output

Press the green "Run" - button, for start the set action.

Whether a analog output is set or not, is defined in the parameter set.



Fig. 12.30: Set analog output

See also chapter 10.5.2 "auto testing".

13. LITE SOFTWARE



13 ELABO Lite-Software

The ELABO Lite software provides different "simple" functions for the control of the device and for the individual testing.

Help function: Prompts for the functions of the Lite software can be displayed over the F1 button.

13.1 CommandLine Tool:

The control commands are listed in the separate manual "Remote control/ Serial remote control G1-G7-series"

13.2 Flash-Programer for Firmware Update

- Control module (G1-1G and G1-1 T)
- Touch display module (G1-1G)

Attention: The firmware update must be carried out via the correct interface.

- Control module via the service interface X9a (X9a)
- Touch display module via interface X9 (Ethernet, USB, RS232)

If the firmware is transferred to the wrong module, the device is no longer able to work. In this case you can transfer again the right firmware with the Flash programmer of the Lite software and such overwrite the wrong entry (pay attention to the right interface).

13.3 Driver test (Treiber Test)

Over this function, single tests can be executed, with individual parameter settings. E.g. HV, ISO tests are possible dependent on the device and its equipment.

The software shows the results of the individual test on the field "Results".

Note: For the execution of individual tests there must exist a physical connection to the unit (interface X9).

13.4 Result Explorer/Messwertspeicher auslesen

The function permits the selections and display of the stored results of the tests (measured data storage). To be able to use the function, the measured data storage must be set to "ON" in the "Setup" of the device (see chapter 10 Setup)

13. LITE SOFTWARE



13.5 RS-Config / Serial interface RS232

The function scans automatically all COM ports of the PC for connected ELABO G1-/ G7 equipment. The function tries to make connection with the device.

If this is successful the found interface and the baud rate are shown and they can be taken.

13.6 Translation Tool



14 Fast-Start-Mode

Note: Integrated from SW-Rel. 7/320/00 /04.

The Fast Start mode works across all types of test, ie HV and IS. Types of test such as HV and IS require only one START in this mode.

An activation of the Fast-Start mode is possible via the menu system (Setup Chap. 10.6) or via the commands (remote control). See also diagrams in Chap. 4.1 and 4.3.

14.1 PREREQUISITES FOR USE OF THE FAST-START MODE:

- Only one type of test either HV or IS.
- Same test parameters of the test object (e.g. use in routine tests in systems with short cycle times).
- Teaching the operating point (test parameters) in the first test.
- Default of the control window (settling parameter) for test voltage (in the menu system or via the commands).

14.2 RESTRICTIONS ON FAST-START MODE:

- Can not run test plans.
- Maximum test duration 5.0 s
- The resultant storage is not active
- The test parameters overview in the display disappears
- Only one Start command is required for the test run.
- Time for the first test (Teaching) plus hook-on the safety function is equal to a test without fast-start mode.
- Displays the total time for the Fast Start Mode test
- (test time + settling time). However, the test time runs in the background.

14.3 GLOSSARY

The Fast-Start mode is a mode that enables a reduction in the cycle time by more of the same (sequential) test circuit. The test item should always be of the same type with almost the same physical properties.

The sequence of a test plan is in this mode not possible and therefore blocked.

The Fast-Start Mode is implemented only in the types of test HV and IS.

14.4 STARTING POSITION:

For equipment of the Best Performance Series the total test time is rather long. A high-voltage test with 1s test time can take up, depending on the test item, to a total of 3 seconds to complete. This is due to various tasks which must be executed during a test run.

For the great "Time overhead" are mainly responsible the parameter setting of the test, the closing and opening of the two-mechanical overload relays



for the two safety circuits (HV and IS), the setting of the test voltage (HV) within a very small control window (without overshoot), the switching to the optimum range (IS) as well as residual voltage monitoring when switching off the test voltage (HV_DC).

In the fast-start mode precious total time should be saved exactly to the above mentioned tasks.

14.5 ACTIVATING FAST START MODE:

The operating mode Fast Start Mode can be switched on/off either via the setup menu in the display (Fig. 10:40 ff) or over the command \$SCM1 (bit_2). At enabled mode, the control windows can be adjusted in addition, this has a positive effect on a shorter total time (\$SDM2(...) or setup menu).

HV:

lowest value: -1000V ... 0V

highest value: 0V to 1000V ... (at least 20V Δ U)

IS:

lowest value: -1000V ... 0V

highest value: 0V to 1000V ... (at least 20V Δ U).

14.6 PARAMETERIZATION OF THE TEST:

One command was generated for the types of test HV and IS, which contains all relevant test parameters for the test. A special feature is that the test time in Fast Start Mode is limited to max. 5 seconds (no endurance test possible). Also, the voltage ramp up and voltage return down should be turned off.

14.7 TEACHING THE UNIT:

Before the first start of a test, the unit must be set the optimal control value of the AC source. This is necessary for the operating point, to obtain the optimal test voltage (for HV) respectively the optimum range (for ISO). Before the first start, the command "\$TEACH" or in the display the button "Teach" can be operated. The unit determines in the next circuit the value and stores it permanently. The value is available in the memory even after turning off the unit . The device can also be taught again any time between the hook-on. At the end of the circuit, an additional routine weighted the actual control value and adjusts the stored value adaptively. The adaptively determined control values are not saved.

It is also **important** that a representative test item is connected to the device.



14.8 STARTING THE TEST:

In the operating mode Fast Start Mode, the test is always started with only one start command. In normal operation are tests which require an increased safety aspect (closed security circuit) always started with 2 start signals.

14.9 FAST-START-MODE VOLTAGE TIME DIAGRAM

Illustrative representation "Teach test" "Fast-Start Mode test".



14.10 PROCEEDINGS OF THE CIRCUIT:

At the first circuit at Fast-Start Mode the unit starts as well as in normal operation from default. The mechanical overload relays for the two safety circuits are checked for faulty condition, then turned on and monitored the switching over. If no error occurs, the test is prepared, the electronic overload relay turns on and presets the first control value from the setting table to the AC power source. Once the system has settled the control cycle is activated, which completely corrects, keeps and monitors the desired value within the control window. Should the unit be taught again, the current set value is copied to the persistent memory, in order that the value at the next circuit can be jumped to directly instead to the setting table value (determined at idle state!). An additional readjustment is thus only in few cases necessary, however, possible at any time.

If the desired value is in the setting window, the test time is started. At the end of the test time the actual desired value is again evaluated and the set value adaptively corrected. Especially for easily changing test conditions this routine is very useful to enable in the future short circuit times. In case of strong deviations it is recommended to teach again.



After testing time has elapsed, the control value of the AC voltage source is reduced to zero and turned off the electronic overload relay. The residual voltage monitoring must not be ignored for security reasons.

The main difference to normal operation is that the two mechanical overload relays for the safety circuits are not opened and the unit does not return at the end of the test sequence to the default state. Instead, the device prepares for the next test and waits in the prepared state for the next start of the following test circuit. In the next test hook-on, the stored setting value is jumped directly to if the unit does not have to re-program.

In the prepared standby condition can be left without error the test sequence chain by a stop signal, and the unit returns to the initial state.

Occurs during the test run an error, the unit will exit the test run chain and always returns to the default state. Then the error, as well as during normal operation, must be acknowledged. The next circuit runs as described above in the initial state.

14.11 MORE FEATURES:

The response to a start command (\$SST) is the status string of the command \$LTS, which is generated automatically at the end of circuit and contains all test results. An additional polling of the device status during the test is not necessary.

The internal result storage is always switched off.

A hood pulse is only generated after the completion of the test circuit or in case of errors (-> device is now in state NONE), since it automatically opens the safety circuit and therefore during the test circuit (-> READY state) gives a safety circuit fault.

14.12 FAST-START-MODE OVERVIEW

Note: See also diagrams in Chap. 4.



14.13 FAST-START-MODE STATUS DISPLAY

At active Fast-Start-Mode in the display of the button is "Teaching" displayed. To activate the teaching process the button must be operated. The teaching button will appear in reverse.



Fig. 14.1: Fast-Start-Mode - teaching active





Attention - High Voltage - danger for life:

High voltage on the test object housing! Don't touch the test object or the wiring.



The test is started by pressing the green RUN button.

The unit performs the test and stores the parameters determined as operating point.



Fig. 14.2: Fast-Start-Mode - teaching ready

In the Fast-Start Mode, the default values in the right section are not displayed because of speed reasons. The field remains gray. In subsequent



tests, the unit sets itself directly to the determined optimal operating point. After reaching the operating point, the unit returns to normal control. Variations are controlled as in normal operation.

Note: By pressing the teaching button the learning process can be repeated any time.



14.14 FAST-START-MODE OVERVIEW

| | Fast-Start-Mode | Normal-Mode |
|-------------------------------------|--|-------------------------------|
| Types of tests | HV, ISO | HV, ISO, IN, OUT, TIME |
| Individual test | only individual test | Individual test possible |
| Test plan | not possible | Test plans possible |
| Test time | max. 5 s | max. 999,9 s, continuity test |
| Time indication | Format 9.999 (total time) | Format 999.9 (test time) |
| Control range | expanded, see settling limits | Default HV/ISO +/-10V |
| Resultant storage | always be deactivated | active / inactive (Setup) |
| Test parameters overview in display | is hidden | appears |
| Test start | one start command | two start command |
| Teach step | first step | |
| | | |
| | | |
| Commands | | |
| Turn on fast mode | \$SCM1(x;1) \$SCM1(the second bit is set) | |
| Turn off fast mode | <pre>\$SCM1(x;0) \$SCM1(the second bit is not set)</pre> | |
| Settling limits | \$SDM2 HVmin: -1000 V 0 V HVmax 0 V 1000 V ISOmin: -1000 V 0 V ISOmax 0 V 1000 V | Default: HV/ISO +/-10V |
| HV-test parameter | \$SHV() | |
| ISO-test parameter | \$SIS() | |
| Teaching | \$TEACH | |
| Test start | \$SST (only once) Return at the end of the test HV/ISO: \$OK(0000;5000;9.99 9;X;100.0000;Y;Z;I) | \$SST (twice) |
| Prompt tester status | \$LTS \$OK(5000;5000;9.999;X;100.0 000;Y;Z;I) | |



15 OPTIONS AND ADD-ONS FOR THE DEVICES

The options described in follow, are special accomplishments or extensions of the standard device. This options must be ordered at factory or the device has to be upgraded also in the factory. A self-upgrade is not permissible by safety reasons.

Over view Options

The number of the device option is attaching the device type.

| | | G1-1A/-1M | | G1-1B/-1N | G1-1C/-1P | G1-1G/-1T | G1-1H/-1U |
|---|-----------|-----------------|-----|----------------|-----------|-----------|-----------|
| | | DC | | | A | С | |
| Device option | Nr. 1) | | | | | | |
| | | | | | | | |
| Insulation resistance IS | E02 | | | | | | |
| Insulation resistance IS | E02-1 | 2,5 GOhm | | 5 GOhm | 1 GOhm | | |
| Safety current limitation | E03 | | | | | • | |
| Voltage read back | E04 | | | • | • | | |
| Burn mode (not in combina- tion with E03) | E05 | | | | | 0 | |
| Additional digital output DIO | E06 | • | | • | • | • | • |
| Expanded.dig./ anal.ln-/Output 16DOut,8DIn,3AOut,2AIn | E07 | • | | • | • | • | • |
| | | | | | | | |
| Lemo teminals | E09 | | | | | | |
| RS232-C | E11 | | | | | • | |
| USB | E12 | • | | • | • | • | • |
| | | | | | | | |
| | | | | | | | |
| Calibration | E99 | • | | • | | • | • |
| | | | | | | | |
| 1) This number is extending | g the dev | /ice type e.g C | G1- | -1A E01 | <u> </u> | I | |
| • not in combination with | other or | otions | | | | | |
| | | | | | | | |



15.1 Option E03 safety current limitation for AC- tester

Option "Safety current limitation" is restricting the output current of the HV-tester to 3 mA. Based of the current limitation, the characteristic of the High Voltage Source is "soft" (see load characteristic diagram).



Note "Unominal not reached": At the lower voltage range, the nominal voltage is not reachable at a high test current. The tester is interrupting the test with the message "Unominal not reached".

Output voltage current-limited EN 50191 (VDE 0104)

Since the output is current-limited, the safety measures according to EN 50191 (VDE 0104,sub-clause 1.2-b), e. g. provision of safeguarding devices at test benches, warning indicator lights, use of devices for protection against electric shock and other necessary protective provisions are not explicitly required.

Touching the current-limited high voltage is not dangerous to life, but can be very painful. Due to the shock, maybe other accidents could happen. Therefore it is advisable to bar off test zones. Prior to use, the equipment and materials must be checked for visible damage and/or defects.

Load characteristic current-limited - AC-Load characteristic



Note: At earth-bound test voltage, the internal leakage current of the device, is reducing the test current. At floating test voltage, the test current is reaching the full 3 mA.







15.2 Voltage Read-back unit E04 (only DC-types)

The read-back unit option E04 serves for controlling if the high voltage is supplying the test item. By this it is guaranteed that the test item is safely bonded and supplied to the correct voltage. In addition to the two HV-energy lines, two sense lines have to be connected to the connecting terminals (four wire measuring).

At devices with display, the parameter Umin itself can be switched on and turned off in the menu, as well as adjusted in the range between 90 and 100% of the test voltage as voltage value in x.xx kV. At automatic devices, this is managed by software order (see manual "remote control - command #SU1(...)").

If the predefined value of Umin is fallen below during an examination, then the device breaks off with the fault "Umin underrun". At automatic devices, becomes at interrogation of the equipment status the fault transmitted - Code Z column 03.

Attention High Voltage !! Do not touch !!:

The two cables of the reed-back unit must always be connected tightly. During an active examination (on switched HV) and HV energy lines not connected the ends of the sense lines are applied to voltage/high voltage.

Attention High Voltage !

The sense leads are under HV potential during the high voltage test. Do not de-connect during the test run.

The intrinsic resistance of the reed-back unit is > 300 MOhm. The current which flows through the body of a person touching the lines is not dangerous, however, can be painful under circumstances.

Technical data feedback unit

100V – 6000 V DC

Accuracy:

1% of reading + 2 Digit at DC This precision applies to not crossed sense lines.

Intrinsic resistance:

Measurement range:

>300 MOhm

Detection of not attached sense leads or HV lines.

Note: Assigning sense lines correctly

For sense operation (Umin active) it is necessary to take notice that the sense terminal X4 is connected together with HV-terminal X2 and sense terminal X5 with HV-terminal X3. The given precision refers to not crossed sense operation.







Fig. 15.2a: Schematic diagram direct



Fig. 15.2b: Schematic diagram via box

EU-Konformitätserklärung

EU-Declaration of Conformity

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Hiermit erklären wir in alleiniger Verantwortung, dass das Produkt We declare under our sole responsibility that the product

| Bezeichnung des Produkts: Designation of the device/equipment: | Hochspannngs-Prüfgeräte <i>High Voltage Tester</i> | |
|---|---|-----------------------|
| Typ/ <i>Type:</i> | G1-1x Gerätereihe | G1-1x device typs |
| Zusätzliche Angaben: Additional information: | BestPerformance | |
| in der gelieferten Ausführung folgen complies with the following provision | den einschlägigen Bes ns applying to it: | timmungen entspricht: |

| EU-Richtlinie: | Niederspannungsrichtlinie EMV-Richtlinie Maschinenrichtlinie | 2014/35/EU 2014/30/EU 2006/42/EG |
|----------------|--|--|
| EU provisions: | Low voltage directive EMC directive Machine guideline | 2014/35/EU 2014/30/EU 2006/42/EC |

Angewendete harmonisierte Normen, insbesondere: *Applied harmonized standards in particular:*

> DIN EN 61326-1; VDE 0843-20-1 DIN EN 61326-2-1; VDE 0843-20-2 DIN IEC 60060-1; VDE 0432-1 DIN EN 60060-2; VDE 0432-2 DIN EN 61180-1; VDE 0432-10 DIN EN 61180-2; VDE 0432-11 DIN EN 61010-1; VDE 0432-11 DIN EN 60204-1; VDE 0411-1 DIN EN 60204-1; VDE 0113-1 DIN EN 13849-1 DIN EN 50191; VDE 0104 (Normen in den jeweils aktuellen Ausführungen)

Dokumentations-Beauftragter : Authorized person for documentation:

Mr. Andreas Bausch, ELABO GmbH

(All standards in actual version)

Thomas Hösle

Name/Name

Unterschrift/Signature

Geschäftsleitung/Management

Funktion/Function

24.05.2016

Datum/Date



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